

### RC18016

JESD204B/C Compliant Fanout Buffers and Dividers

### Description

The RC18016 is a fully integrated clock and SYSREF signal fanout buffer for JESD204B/C applications. The device provides a high-performance clock and converter synchronization solution for wireless base station radio equipment boards with JESD204B/C subclass 0, 1, and 2 compliance. The main function of the device is the distribution and fanout of high-frequency clocks and low-frequency system reference signals generated by a JESB204B clock generator such as the RC38612, extending its fanout capabilities and providing additional phase-delay. The RC18016 is optimized to deliver very low phase noise clocks and precise, phase-adjustable SYSREF synchronization signals.

The RC18016 distributes the input clock (CLK) and JESD204B SYSREF signals (REF) to four fanout channels. Input clock signals can be frequency divided and are fanned-out to multiple clock (QCLK\_y) and SYSREF (QREF\_r) outputs. Configurable phase-delay circuits are available for both clock and SYSREF signals. The propagation delays in all signal paths are fully deterministic to support fixed phase relationships between clock and SYSREF signals within one device. The device facilitates synchronization between frequency dividers within one device and across multiple devices, removing phase ambiguity introduced in dividers between power and configuration cycles.

### **Applications**

- Wireless infrastructure applications: 4G, 5G, and mmWave
- Frequency divider synchronization across multiple devices
- Ideal clock driver for jitter-sensitive ADC and DAC circuits
- Radar, imaging, instrumentation, and medical

#### **Features**

- Distribution, fanout, phase-delay of clock, and SYSREF signals
- Low output noise floor: -163dBc/Hz (245.76MHz)
- Supports clock frequencies up to 3GHz, including clock output frequencies of 983.04MHz, 491.52MHz, 245.76MHz, and 122.88MHz
- Phase alignment mode across multiple buffers with any frequency divider setting
- Configuration through 3-wire SPI interface
- Supply voltage:
  - 3.3V core and signal I/O
  - 1.8V digital control SPI I/O (3.3V-tolerant inputs)
- · Reference inputs are fail-safe
- Provides four output channels with a total of 16 differential outputs
- Outputs channels include:
  - · Dedicated clock outputs
  - Outputs configurable as SYSREF outputs with individual phase delay stages, or configurable as additional clock outputs
  - · Clock outputs are powered-on/enabled at startup
  - · QREF\_r (SYSREF) outputs disabled at startup
- Each clock channel contains:
  - Frequency Dividers: ÷1, ÷2, ÷3, ÷4, ÷6, ÷8, ÷12, ÷16, ÷24
  - Clock phase delay circuits, delay unit is the clock period; 256 steps
- SYSREF: Configurable precision phase delay circuits: 8 steps of 131ps, 262ps, 393ps, or 524ps
- Flexible differential outputs:
  - LVDS/LVPECL/AC-HCSL
  - · Amplitude configurable for LVDS and LVPECL
  - · Power-down modes for unused outputs
  - · Supports DC and AC coupling
  - QREF\_r (SYSREF) output pre-bias feature to prevent glitches when turning output on or off
- Package: 64-VFQFPN (9.0 × 9.0 × 0.85 mm)
- Ambient temperature range: -40°C to +105°C (case)

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## 1. Block Diagram

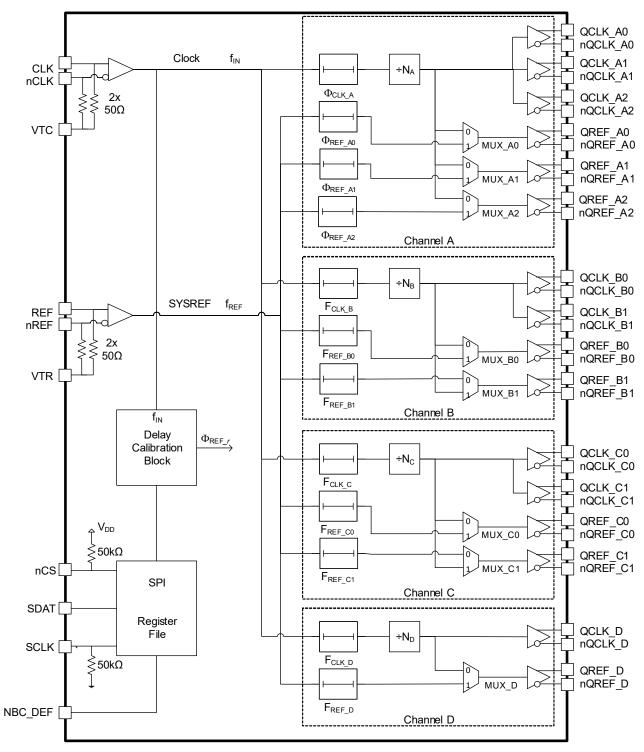


Figure 1. Block Diagram

## 2. Pin Information

## 2.1 Pin Assignments

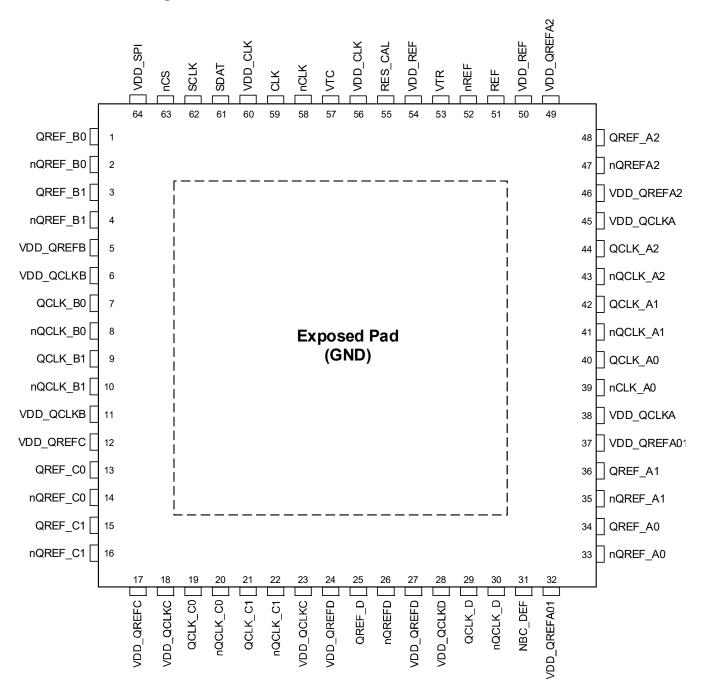


Figure 2. Pin Assignments, 64-VFQFPN Package (Top View)

# 2.2 Pin Descriptions

**Table 1. Pin Descriptions** 

| Pin<br>Number | Pin Name                | Type <sup>[1]</sup> | Description  |
|---------------|-------------------------|---------------------|--|
| 1,<br>2       | QREF_B0,<br>nQREF_B0    | Output              | Differential SYSREF/clock output QREF_B0. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation. |
| 3,<br>4       | QREF_B1,<br>nQREF_B1    | Output              | Differential SYSREF/clock output QREF_B1. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation. |
| 5             | $V_{DD\_QREFB}$         | Power               | Positive supply voltage (3.3V) for the QREF_B[1:0] outputs.  |
| 6             | V <sub>DD_QCLKB</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_B[1:0] outputs.  |
| 7,<br>8       | QCLK_B0,<br>nQCLK_B0    | Output              | Differential clock output QCLK_B0. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 9,<br>10      | QCLK_B1,<br>nQCLK_B1    | Output              | Differential clock output QCLK_B1. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 11            | V <sub>DD_QCLKB</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_B[1:0] outputs.  |
| 12            | V <sub>DD_QREFC</sub>   | Power               | Positive supply voltage (3.3V) for the QREF_C[1:0] outputs.  |
| 13,<br>14     | QREF_C0,<br>nQREF_C0    | Output              | Differential SYSREF/clock output QREF_C0. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation. |
| 15,<br>16     | QREF_C1,<br>nQREF_C1    | Output              | Differential SYSREF/clock output QREF_C1. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation. |
| 17            | V <sub>DD_QREFC</sub>   | Power               | Positive supply voltage (3.3V) for the QREF_C[1:0] outputs.  |
| 18            | V <sub>DD_QCLKC</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_C[1:0] outputs.  |
| 19,<br>20     | QCLK_C0,<br>nQCLK_C0    | Output              | Differential clock output QCLK_C0. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 21,<br>22     | QCLK_C1,<br>nQCLK_C1    | Output              | Differential clock output QCLK_C1. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 23            | V <sub>DD_QCLKC</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_C[1:0] outputs.  |
| 24            | $V_{DD\_QREFD}$         | Power               | Positive supply voltage (3.3V) for the QREF_D outputs.   |
| 25,<br>26     | QREF_D,<br>nQREF_D      | Output              | Differential SYSREF/clock output QREF_D. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation.  |
| 27            | $V_{DD\_QREFD}$         | Power               | Positive supply voltage (3.3V) for the QREF_D outputs.   |
| 28            | V <sub>DD_QCLKD</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_D outputs.   |
| 29,<br>30     | QCLK_D,<br>nQCLK_D      | Output              | Differential clock output QCLK_D. Configurable LVPECL/LVDS/AC-HCSL style and amplitude   |
| 31            | NBC_DEF                 | Input (PU)          | Sets the default (power-up) value of the least significant bit of the NB and NC frequency dividers. Fail-safe input.                                 |
| 32            | V <sub>DD_QREFA01</sub> | Power               | Positive supply voltage (3.3V) for the QREF_A[1:0] outputs.  |
| 33,<br>34     | nQREF_A0,<br>QREF_A0    | Output              | Differential SYSREF/clock output QREF_A0. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation. |
| 35,<br>36     | nQREF_A1,<br>QREF_A1    | Output              | Differential SYSREF/clock output QREF_A1. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation. |
| 37            | V <sub>DD_QREFA01</sub> | Power               | Positive supply voltage (3.3V) for the QREF_A[1:0] outputs.  |
| 38            | V <sub>DD_QCLKA</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_A[2:0] outputs.  |
| 39,<br>40     | nQCLK_A0,<br>QCLK_A0    | Output              | Differential clock output QCLK_A0. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 41,<br>42     | nQCLK_A1,<br>QCLK_A1    | Output              | Differential clock output QCLK_A1. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 43,<br>44     | nQCLK_A2,<br>QCLK_A2    | Output              | Differential clock output QCLK_A2. Configurable LVPECL/LVDS/AC-HCSL style and amplitude.   |
| 45            | V <sub>DD_QCLKA</sub>   | Power               | Positive supply voltage (3.3V) for the QCLK_A[2:0] outputs.  |
| 46            | V <sub>DD_QREFA2</sub>  | Power               | Positive supply voltage (3.3V) for the QREF_A2 output.   |

Table 1. Pin Descriptions (Cont.)

| Pin<br>Number       | Pin Name               | Type <sup>[1]</sup> | Description   |
|---------------------|------------------------|---------------------|---|
| 47,<br>48           | nQREF_A2,<br>QREF_A2   | Output              | Differential SYSREF/clock output QREF_A2. LVDS style for SYSREF operation, configurable LVPECL/LVDS/AC-HCSL style and amplitude for clock operation.  |
| 49                  | V <sub>DD_QREFA2</sub> | Power               | Positive supply voltage (3.3V) for the QREF_A2 output.  |
| 50                  | V <sub>DD_REF</sub>    | Power               | Positive supply voltage (3.3V) for the differential SYSREF input REF, nREF.   |
| 51, 52              | REF, nREF              | Input               | SYSREF inverting and non-inverting differential input. Compatible with LVPECL and LVDS signals. REF and nREF are internally $50\Omega$ terminated to the VTR pin. Fail-safe input.  |
| 53                  | VTR                    | -                   | Internal termination for the differential clock input REF, nREF. Both REF and nREF inputs are internally terminated $50\Omega$ to this pin. See input termination information in Application Information. Fail-safe input.    |
| 54                  | V <sub>DD_REF</sub>    | Power               | Positive supply voltage (3.3V) for the differential SYSREF input REF, nREF  |
| 55                  | RES_CAL                | Analog              | Connect a 2.8 kΩ (1%) resistor to GND for output current calibration.   |
| 56                  | V <sub>DD_CLK</sub>    | Power               | Positive supply voltage (3.3V) for the differential device clock input CLK, nCLK.   |
| 57                  | VTC                    | -                   | Internal termination for the differential clock input CLK, nCLK. Both CLK and nCLK inputs are internally $50\Omega$ terminated to the VTR pin. See input termination information in Application Information. Fail-safe input. |
| 58, 59              | nCLK, CLK              | Input               | Device clock inverting and non-inverting differential clock input. Compatible with LVPECL and LVDS signals. CLK and nCLK are internally terminated to VTC through $50\Omega$ . Fail-safe input.                               |
| 60                  | V <sub>DD_CLK</sub>    | Power               | Positive supply voltage (3.3V) for the differential device clock input CLK, nCLK.   |
| 61                  | SDAT                   | Input/<br>Output    | Serial Control Port SPI Mode Data Input and Output. 1.8V LVCMOS/LVTTL interface levels. 3.3V tolerant when input.   |
| 62                  | SCLK                   | Input (PD)          | Serial Control Port SPI Mode Clock Input. 1.8V LVCMOS/LVTTL interface levels. 3.3V-tolerant when input.   |
| 63                  | nCS                    | Input (PU)          | Serial Control Port SPI Chip Select Input. 1.8V LVCMOS/LVTTL interface levels and 3.3V tolerant.  |
| 64                  | $V_{DD\_SPI}$          | Power               | Positive supply voltage (3.3V) for the SPI interface.   |
| Exposed<br>Pad (EP) | GND                    | Power               | Ground supply voltage (GND) and ground return path. Connect to board GND (0V).  |

<sup>1.</sup> Internal pull-up (PU) and pull-down (PD) resistors are indicated in parentheses. See Table 5 for values.

## 3. Specifications

## 3.1 Absolute Maximum Ratings

**Caution**: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions can adversely impact product reliability and result in failures not covered by warranty.

**Table 2. Absolute Maximum Ratings** 

| Item   | Minimum                   | Maximum                 | Unit |
|--|---------------------------|-------------------------|------|
| Supply Voltage, V <sub>DD_V</sub>  | -                         | 3.6                     | V    |
| Inputs   | -0.5 to V <sub>DD_V</sub> | V <sub>DD_V</sub> + 0.5 | V    |
| Outputs, V <sub>O</sub> (LVCMOS)   | -0.5 to V <sub>DD_V</sub> | V <sub>DD_V</sub> + 0.5 | V    |
| Outputs, I <sub>O</sub> (LVPECL) Continuous Current Surge Current        |                           | 50<br>100               | mA   |
| Outputs, I <sub>O</sub> (LVDS)<br>Continuous Current<br>Surge Current    |                           | 50<br>100               | mA   |
| Outputs, I <sub>O</sub> (AC-HCSL)<br>Continuous Current<br>Surge Current |                           | 50<br>100               | mA   |
| Input Termination Current, I <sub>VT</sub>                               | -35                       | 35                      | mA   |
| Junction Temperature, T <sub>J</sub>                                     | -                         | 150                     | °C   |
| Storage Temperature, T <sub>STG</sub>                                    | -65                       | 150                     | °C   |
| ESD – Human Body Model [1]   | -                         | 2000                    | V    |
| ESD – Charged Device Model [1]   | -                         | 500                     | V    |

<sup>1.</sup> According to JEDEC JS-001-2012/JESD22-C101.

## 3.2 Recommended Operating Conditions

**Table 3. Recommended Operating Conditions** 

| Item  | Minimum | Maximum | Unit |
|---|---------|---------|------|
| Supply Voltage, V <sub>DD_V</sub>                             | -       | 3.3     | V    |
| Operating Junction Temperature, T <sub>J</sub> <sup>[1]</sup> | -       | 125     | °C   |
| Board Temperature, T <sub>B</sub>                             | -       | 105     | °C   |

 <sup>1. 125°</sup>C/10year lifetime is based on the evaluation of intrinsic wafer process technology reliability metrics. The limiting wafer level reliability factor
for this technology with respect to high temperature operation is electro-migration. The device is verified to the maximum operating junction
temperature through simulation.

## 3.3 Thermal Specifications

Table 4. Thermal Resistance for 64-VFQFPN Package [1]

| Symbol        | Thermal Parameter   | Condition      | Value | Unit |
|---------------|---------------------|----------------|-------|------|
|               |                     | 0 m/s air flow | 22.76 | °C/W |
|               |                     | 1 m/s air flow | 19.25 | °C/W |
| 0             | Junction to ambient | 2 m/s air flow | 17.70 | °C/W |
| $\Theta_{JA}$ | Junction to ambient | 3 m/s air flow | 16.87 | °C/W |
|               |                     | 4 m/s air flow | 16.37 | °C/W |
|               |                     | 5 m/s air flow | 16.03 | °C/W |

Table 4. Thermal Resistance for 64-VFQFPN Package [1] (Cont.)

| Symbol            | Thermal Parameter | Condition | Value | Unit |
|-------------------|-------------------|-----------|-------|------|
| $\Theta_{\sf JC}$ | Junction to case  | -         | 14.33 | °C/W |
| $\Theta_{JB}$     | Junction to board | -         | 1.1   | °C/W |

<sup>1.</sup> Standard JEDEC 2S2P multilayer PCB.

### 3.4 Pin Characteristics

Table 5. Pin Characteristics,  $V_{DD\ V}$  = 3.3V ±5%,  $T_A$  = -40°C to +105°C

| Symbol           | Parameter                | Test Conditions    | Minimum | Typical | Maximum | Unit |
|------------------|--------------------------|--------------------|---------|---------|---------|------|
| C <sub>IN</sub>  | Input Capacitance        | -                  | -       | 2       | 4       | pF   |
| R <sub>PD</sub>  | Input Pull-Down Resistor | SCLK               | -       | 51      | -       | kΩ   |
| R <sub>PU</sub>  | Input Pull-Up Resistor   | nCS                | -       | 51      | -       | kΩ   |
| R <sub>OUT</sub> | LVCMOS Output Impedance  | SDAT (when output) | -       | 25      | -       | Ω    |

### 3.5 DC Characteristics

Table 6. Power Supply DC Characteristics,  $V_{DD_V} = 3.3V \pm 5\%$ ,  $T_A = -40$ °C to +105°C [1]

| Symbol                     | Parameter            | Test Conditions  | Minimum | Typical | Maximum | Unit |
|----------------------------|----------------------|--|---------|---------|---------|------|
| $V_{DD_{\_V}}$             | Core Supply Voltage  | -  | 3.135   | 3.3     | 3.465   | V    |
| I <sub>DD</sub><br>(Total) | Power Supply Current | QCLK_y and QREF_r set to LVDS, 750mV amplitude, terminated $100\Omega$ , Nx dividers set to $\div 1$ | -       | 820     | 960     | mA   |

<sup>1.</sup> Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

Table 7. Typical Power Supply Current Characteristics,  $V_{DD_V} = 3.3V$ ,  $T_A = 25^{\circ}C$  [1][2]

| Symbol                 | Supply B   | in Current                 |        |        | ,    | Test Case |      |      |      | Unit  |
|------------------------|--|----------------------------|--------|--------|------|-----------|------|------|------|-------|
| Syllibol               | Supply Pin Current   |                            | 1      | 2      | 3    | 4         | 5    | 6    | 7    | Ollit |
|                        |  | Style                      | LVPECL | LVPECL | LVDS | AC-HCSL   | LVDS | LVDS | LVDS | -     |
| -                      | QCLK_y   | State                      | On     | On     | On   | On        | On   | On   | On   | -     |
|                        |  | Amplitude                  | 350    | 750    | 350  | 500       | 350  | 750  | 750  | mV    |
|                        |  | Style                      | LVDS   | LVDS   | LVDS | LVDS      | LVDS | LVDS | LVDS | -     |
| -                      | QREF_r   | State                      | Off    | Off    | Off  | Off       | On   | On   | On   | -     |
|                        |  | Amplitude                  | -      | -      | -    | -         | 350  | 350  | 750  | mV    |
| I <sub>DD_SRC</sub>    | Current through the V <sub>DD_SPI</sub> , V <sub>DD_REF</sub> , V <sub>DD_CLK</sub> pins       |                            | 137    | 137    | 190  | 191       | 192  | 190  | 189  | mA    |
| I <sub>DD_CLKA</sub>   | Current through the  | V <sub>DD_QCLKA</sub> pins | 35     | 42     | 84   | 144       | 84   | 109  | 109  | mA    |
| I <sub>DD_CLKBCD</sub> | Current through the V <sub>DD_QCLKB</sub> , V <sub>DD_QCLKC</sub> , V <sub>DD_QCLKD</sub> pins |                            | 103    | 115    | 114  | 276       | 176  | 216  | 214  | mA    |
| I <sub>DD_REFA</sub>   | Current through the V <sub>DD_QREFA01</sub> , V <sub>DD_QREFA2</sub> pins                      |                            | 4      | 4      | 9    | 9         | 72   | 67   | 98   | mA    |
| I <sub>DD_REFBCD</sub> | Current through the V <sub>DD_QREFB</sub> , V <sub>DD_QREFC</sub> , V <sub>DD_QREFD</sub> pins |                            | 7      | 7      | 15   | 15        | 120  | 111  | 164  | mA    |

<sup>1.</sup>  $f_{IN}$  (input) = 491.52MHz,  $f_{SYSREF}$  = 7.68MHz, NA = 0x0000 (÷1), NB = 0x0011 (÷4).

<sup>2.</sup> QCLK\_y and QREF\_r outputs unloaded.

Table 8. LVCMOS DC Characteristics,  $V_{DD\_V}$  = 3.3V  $\pm$  5%,  $T_A$  = -40°C to +105°C [1]

| Symbol          | Parameter          |         | Test Conditions                                  | Minimum | Typical | Maximum        | Unit |
|-----------------|--------------------|---------|--|---------|---------|----------------|------|
| V <sub>IH</sub> | Input High Voltage | NBC DEF | -  | 2.0     | -       | $V_{DD_{\_}V}$ | V    |
| V <sub>IL</sub> | Input Low Voltage  | NBC_DEF | -  | -0.3    | -       | 0.8            | V    |
| I <sub>IH</sub> | Input High Current | NBC DEE | V <sub>DD_V</sub> = 3.3V, V <sub>IN</sub> = 3.3V | -       | -       | 5              | μΑ   |
| I <sub>IL</sub> | Input Low Current  | NBC_DEF | V <sub>DD_V</sub> = 3.3V, V <sub>IN</sub> = 0V   | -150    | -       | -              | μA   |

Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in
a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been
reached under these conditions.

Table 9. LVCMOS (JESD8-7A, 1.8V) DC Characteristics,  $V_{DD_V} = 3.3V \pm 5\%$ ,  $T_A = -40$ °C to +105°C [1][2]

| Symbol          | Parameter                              |                    | Test Conditions                                  | Minimum | Typical | Maximum | Unit |
|-----------------|--|--------------------|--|---------|---------|---------|------|
| V <sub>T+</sub> | Positive-going input threshold voltage |                    | -  | 0.660   | -       | 1.365   | V    |
| V <sub>T-</sub> | Negative-going input threshold voltage | SCLK, nCS, SDAT    | -  | 0.495   | -       | 1.170   | V    |
| V <sub>H</sub>  | Hysteresis Voltage                     |                    | $V_{T+} - V_{T-}$                                | 0.165   | -       | 0.780   | V    |
| I <sub>IH</sub> | Input High Current                     |                    | V <sub>DD_V</sub> = 3.3V, V <sub>IN</sub> = 1.8V | -       | -       | 150     | μΑ   |
| I <sub>IL</sub> | Input Low Current                      |                    | V <sub>DD_V</sub> = 3.465V, V <sub>IN</sub> = 0V | -150    | -       | -       | μΑ   |
| V <sub>OH</sub> | Output High Voltage                    | SDAT (when output) | I <sub>OH</sub> = -4mA                           | 1.4     | -       | -       | V    |
| V <sub>OL</sub> | Output Low Voltage                     | SDAT (when output) | I <sub>OL</sub> = 4mA                            | -       | -       | 0.45    | V    |

Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

Table 10. Differential Input DC Characteristics,  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C [1]

| Symbol               | Parameter                     |                        | Test Conditions | Minimum | Typical | Maximum | Unit |
|----------------------|-------------------------------|------------------------|-----------------|---------|---------|---------|------|
| R <sub>IN</sub>      | Input Resistance              | CLK, nCLK<br>REF, nREF | -               | 43.5    | 50      | 56.5    | Ω    |
| R <sub>IN_DIFF</sub> | Differential Input Resistance | CLK, nCLK<br>REF, nREF | -               | 87      | 100     | 113     | Ω    |

Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

Table 11. LVPECL DC Characteristics  $V_{DD\_V}$  = 3.3V  $\pm$  5%,  $T_A$  = -40°C to +105°C  $^{[1]}$ 

| Symbol          | Parameter               | Test Conditions          | Minimum                  | Typical                  | Maximum                  | Unit |
|-----------------|-------------------------|--------------------------|--------------------------|--------------------------|--------------------------|------|
| V <sub>OH</sub> | Output High Voltage [2] | Any Amplitude Setting    | V <sub>DD_V</sub> - 1.20 | V <sub>DD_V</sub> - 0.90 | V <sub>DD_V</sub> - 0.60 | V    |
|                 |                         | 350mV Amplitude Setting  | V <sub>DD_V</sub> - 1.40 | V <sub>DD_V</sub> - 1.24 | V <sub>DD_V</sub> - 1.05 | V    |
| $V_{OL}$        | Output Low Voltage [2]  | 750mV Amplitude Setting  | V <sub>DD_V</sub> - 1.90 | V <sub>DD_V</sub> - 1.71 | V <sub>DD_V</sub> - 1.60 | V    |
|                 |                         | 1000mV Amplitude Setting | V <sub>DD_V</sub> - 2.20 | V <sub>DD_V</sub> - 1.98 | V <sub>DD_V</sub> - 1.80 | V    |

Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

<sup>2.</sup> Table is valid for the SPI interface pins nCS, SCLK and SDAT. SPI inputs have hysteresis.

<sup>2.</sup> Outputs terminated with  $50\Omega$ to V<sub>T</sub> = V<sub>DD\_V</sub> - 1.6V (350mV amplitude setting), V<sub>DD\_V</sub> - 2.0V (750mV amplitude setting), V<sub>DD\_V</sub> - 2.25V (1000mV amplitude setting)

Table 12. LVDS DC Characteristics  $V_{DD\_V}$  = 3.3V  $\pm$  5%,  $T_A$  = -40°C to +105°C [1][2]

| Symbol           | Parameter                        | Test Conditions         | Minimum | Typical | Maximum | Unit |
|------------------|----------------------------------|-------------------------|---------|---------|---------|------|
| V                | Offset Voltage [3]               | 350mV Amplitude Setting | 1.20    | 1.25    | 1.30    | V    |
| V <sub>OS</sub>  | Oliset Voltage 1-3               | 750mV Amplitude Setting | 1.25    | 1.30    | 1.35    | V    |
| ΔV <sub>OS</sub> | V <sub>OS</sub> Magnitude Change | -                       | -       | -       | 50      | mV   |

<sup>1.</sup> Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

- 2. Outputs are terminated  $100\Omega$ .
- 3.  $V_{OS}$  changes with  $V_{DD\ V.}$

Table 13. AC-HCSL DC Characteristics  $V_{DD_{L}V}$  = 3.3V ± 5%,  $T_{A}$  = -40°C to +105°C [1][2]

| Symbol | Parameter      | Test Conditions | Minimum | Typical | Maximum | Unit |
|--------|----------------|-----------------|---------|---------|---------|------|
| Vos    | Offset Voltage | -               | 0.60    | 0.76    | 0.92    | V    |

Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

#### 3.6 AC Characteristics

Table 14. AC Characteristics,  $V_{DD\_V}$  = 3.3V ± 5%,  $T_A$  = -40°C to +105°C [1]

| Symbol               | Parameter                                      |                        | Test Conditions   | Minimum  | Typical | Maximum                                      | Unit |
|----------------------|--|------------------------|---|----------|---------|--|------|
|                      |  |                        | Single device   | 0        | 983.04  | 3000   | MHz  |
| f <sub>IN</sub>      | Input Frequency [2]                            | CLK, nCLK              | Phase alignment between multiple devices                            | >0       | -       | 1000   | MHz  |
|                      |  |                        | SYSREF operation  | 0        | -       | 100  | MHz  |
| f <sub>REF</sub>     | Input Frequency                                | REF, nREF              | During multi-device phase alignment [3] N_ALIGN = ÷24 N_ALIGN = ÷48 | >0<br>>0 | -       | f <sub>IN</sub> ÷ 48<br>f <sub>IN</sub> ÷ 96 | MHz  |
| V <sub>IN</sub>      | Input Voltage<br>Amplitude <sup>[4]</sup>      | CLK, nCLK<br>REF, nREF | -   | 0.15     | -       | 1.2  | V    |
| V <sub>DIFF_IN</sub> | Differential Input Voltage<br>Amplitude [4][5] | CLK, nCLK<br>REF, nREF | -   | 0.3      | -       | 2.4  | V    |
| V <sub>CMR</sub>     | Common Mode Input Volt                         | tage                   | -   | 1        |         | V <sub>DD_V</sub> –<br>(V <sub>IN</sub> / 2) | V    |
| f <sub>OUT</sub>     | Output Frequency                               |                        | QCLK_y, QREF_r (Clock),<br>N = ÷1 to ÷24                            | 0        | 983.04  | 3000 ÷N                                      | MHz  |
|                      |  |                        | QREF_r (SYSREF)   | 0        |         | 100  | MHz  |
|                      | Output Duty Cycle <sup>[6]</sup>               |                        | QCLK_y, QREF_r (Clock),<br>f <sub>IN</sub> ≤ 2500MHz                | 45       | 50      | 55   | %    |
| odc                  |  |                        | QCLK_y, QREF_r (Clock),<br>2500MHz < f <sub>IN</sub> ≤ 3000MHz      | 42       | 50      | 58   | %    |
|                      |  |                        | QREF_r (SYSREF at 7.68MHz)  | 45       | 50      | 55   | %    |

<sup>2.</sup> Outputs are terminated  $50\Omega$  to ground.

Table 14. AC Characteristics,  $V_{DD\_V}$  = 3.3V  $\pm$  5%,  $T_A$  = -40°C to +105°C <sup>[1]</sup> (Cont.)

| Symbol                          | Parameter   | Test Conditions   | Minimum | Typical | Maximum | Unit |
|---------------------------------|---|---|---------|---------|---------|------|
|                                 |   | QCLK_y, QREF_r (LVPECL),<br>20% to 80%  | -       | -       | 250     | ps   |
|                                 | Output Disc./Full Time  | QCLK_y, QREF_r (LVDS),<br>20% to 80%  | -       | -       | 250     | ps   |
| t <sub>R</sub> / t <sub>F</sub> | Output Rise/Fall Time   | QCLK_y, QREF_r (AC-HCSL),<br>20% to 80%   |         |         | 250     | ps   |
|                                 |   | QREF_r (SYSREF, LVDS),<br>20% to 80%  | -       | -       | 250     | ps   |
|                                 |   | 350mV Amplitude Setting   | 250     | 350     | 450     | mV   |
|                                 | LVPECL Output Voltage Swing, Peak-<br>to-Peak, 491.52MHz                        | 750mV Amplitude Setting   | 650     | 750     | 850     | mV   |
| V <sub>O(PP)</sub>              | 10-1 Car, 401.021VII IZ   | 1000mV Amplitude Setting  | 900     | 1000    | 1100    | mV   |
| V <sub>O(PP)</sub><br>[7]       |   | 350mV Amplitude Setting   | 500     | 700     | 900     | mV   |
|                                 | LVPECL Differential Output Voltage<br>Swing, Peak-to-peak, 491.52MHz            | 750mV Amplitude Setting   | 1300    | 1500    | 1700    | mV   |
|                                 | Swing, Fear-to-pear, 491.32WHZ  | 1000mV Amplitude Setting  | 1800    | 2000    | 2200    | mV   |
|                                 | LVDS Output Voltage Swing, Peak-to-   | 350mV Amplitude Setting   | 250     | 350     | 450     | mV   |
| V <sub>O(PP)</sub>              | Peak, 491.52MHz   | 750mV Amplitude Setting   | 600     | 750     | 900     | mV   |
| V <sub>O(PP)</sub><br>[8]       | LVDS Differential Output Voltage  | 350mV Amplitude Setting   | 500     | 700     | 900     | mV   |
|                                 | Swing, Peak-to-Peak, 491.52MHz  | 750mV Amplitude Setting   | 1200    | 1500    | 1800    | mV   |
| V <sub>O(PP)</sub>              | AC-HCSL Differential Output Voltage<br>Swing, Peak-to-Peak, 491.52MHz           | -   | 430     | 480     | 550     | mV   |
|                                 |   | QCLK_y (same N divider) [11]  | -       | -       | 100     | ps   |
|                                 | [0](40)   | QCLK_y (any N divider, incident rising edge)  | -       | -       | 100     | ps   |
| tsk(o)                          | Output Skew <sup>[9][10]</sup> ,<br>All delays set to 0                         | QREF_r (Clock)  | -       | -       | 100     | ps   |
|                                 | 7 iii delays set to s   | QREF_r (SYSREF)   | -       | -       | 100     | ps   |
|                                 |   | QCLK_y to QREF_r (QREF_r as clock output) [11]  | -       | -       | 200     | ps   |
| <i>t</i> sk(pp)                 | Part-to-Part Skew   | CLK to any QCLK_y [11]  | -       | -       | 375     | ps   |
| ισκ(μμ)                         | All delays set to 0   | REF to any QREF_r   | -       | -       | 375     | ps   |
| +                               | Propagation Delay [11]  | CLK to QCLK_y[11]   | 250     | -       | 750     | ps   |
| t <sub>PD</sub>                 | All Delay Circuits set to 0   | REF to QREF_ $r$ ( $\Phi$ REF_ $y$ = 0)   | 600     | 800     | 1000    | ps   |
| Δt <sub>PD</sub>                | Propagation Delay Variation between<br>the Clock Input and any QCLK_y<br>Output | CLK to QCLK_y [11]  | -100    | -       | +100    | ps   |
| t <sub>S</sub>                  | Setup Time [12]   | REF to CLK (rising)   | -       | -       | 250     | ps   |
| t <sub>H</sub>                  | Hold Time   | CLK (rising) to REF   | -       | -       | 250     | ps   |
|                                 | Output Isolation between any  | f <sub>QCLK_y</sub> = 983.04MHz [ <sup>13</sup> ]                                       | 60      | -       | -       | dB   |
| -                               | QCLK_y-QCLK_y and   | f <sub>QCLK_y</sub> = 491.52MHz [ <sup>13</sup> ]                                       | 65      | -       | -       | dB   |
|                                 | QREF_r-QREF_r outputs   | f <sub>QCLK_y</sub> = 245.76MHz [13]  | 70      | -       | -       | dB   |
| -                               | Output Isolation between any QREF_r/QCLK_y outputs                              | f <sub>QCLK_y</sub> = 983.04MHz, 491.52MHz,<br>245.76MHz; f <sub>QREF_r</sub> = 7.68MHz | 50      | -       | -       | dB   |

<sup>1.</sup> Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

<sup>2.</sup> The CLK, nCLK input supports 0Hz if the applied static signal has a minimum amplitude as specified by  $V_{IN}$ ,  $V_{DIFF\_IN}$ .

<sup>3.</sup> Only applicable to a multi-device phase alignment procedure as a max frequency for applying multiple edges to the REF input. This specification is not applicable if a single REF edge is used for multi-device phase alignment.

<sup>4.</sup>  $V_{IL}$  should not be less than -0.3V and  $V_{IH}$  should not be greater than  $V_{DD\_V.}$ 

<sup>5.</sup> Common Mode Input Voltage is defined as the cross-point voltage.

- 6. Input = 50% duty cycle.
- LVPECL outputs terminated with 50Ω to V<sub>T</sub> = V<sub>DD\_V</sub> 1.6V (350mV amplitude setting), V<sub>DD\_V</sub> 2.0V (750mV amplitude setting), V<sub>DD\_V</sub> 2.25V (1000mV amplitude setting).
- 8. LVDS outputs terminated 100Ω across Q, nQ.
- 9. This parameter is defined in accordance with JEDEC standard 65.
- 10. Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential cross points.
- 11. All frequency dividers N are in ÷1, ÷2, ÷4 or ÷8; output amplitude setting 750mV.
- 12. Failure to meet CLK/REF setup and hold time can result in a failure to align output phases across multiple devices.
- 13. Output amplitudes set to 350mV or 750mV.

Table 15. DCB and Phase Delay Characteristics,  $V_{DD}$   $_{V}$  = 3.3V ± 5%,  $T_{A}$  = -40°C to +105°C [1]

| Symbol                         | Parameter                       | Test C  | Conditions              | Minimum | Typical | Maximum | Unit |
|--------------------------------|---------------------------------|---|-------------------------|---------|---------|---------|------|
| f <sub>DCO</sub>               | DCO Lock Range                  |   | -                       | 963.04  | 983.04  | 1003.04 | MHz  |
|                                |                                 |   | DLC = 1 (DLC[1:0] = 00) | 115     | 131     | 150     | ps   |
|                                |                                 | f - 002 04MH-   | DLC = 2 (DLC[1:0] = 01) | 230     | 262     | 300     | ps   |
|                                |                                 | f <sub>DCO</sub> = 983.04MHz  | DLC = 3 (DLC[1:0] = 10) | 345     | 393     | 450     | ps   |
|                                |                                 |   | DLC = 4 (DLC[1:0] = 11) | 460     | 524     | 600     | ps   |
|                                |                                 |   | DLC = 1 (DLC[1:0] = 00) | 113     | 134     | 152     | ps   |
| <b>-</b>                       | ADEE * Dolov Unit Dongo         | f <sub>DCO</sub> = 963.04MHz  | DLC = 2 (DLC[1:0] = 01) | 226     | 268     | 304     | ps   |
| T <sub>DCB</sub>               | ΦREF_ <i>r</i> Delay Unit Range | (min DCO frequency)   | DLC = 3 (DLC[1:0] = 10) | 339     | 402     | 456     | ps   |
|                                |                                 |   | DLC = 4 (DLC[1:0] = 11) | 452     | 536     | 608     | ps   |
|                                |                                 |   | DLC = 1 (DLC[1:0] = 00) | 112     | 128     | 142     | ps   |
|                                |                                 | f <sub>DCO</sub> = 1003.04MHz                                       | DLC = 2 (DLC[1:0] = 01) | 224     | 256     | 284     | ps   |
|                                |                                 | (max DCO frequency)   | DLC = 3 (DLC[1:0] = 10) | 336     | 384     | 426     | ps   |
|                                |                                 |   | DLC = 4 (DLC[1:0] = 11) | 448     | 512     | 568     | ps   |
| T <sub>IN</sub> <sup>[2]</sup> | ΦCLK_x Delay Unit               | f <sub>IN</sub> = 983.04MHz   | -                       | -       | 1017    | -       | ps   |
| f <sub>1,</sub> f <sub>2</sub> | DCO Phase Detector<br>Frequency | -   | -                       | -       | -       | 200     | MHz  |
| $\Delta t_{	extsf{D}}$         | Delay unit variation            | ΦREF_r delay unit variation (deviation from nominal, DLC[1:0] = 00) | -                       | -30     | 0       | +30     | ps   |
|                                |                                 | ΦCLK_y delay unit variation (deviation from nominal)                | -                       | -20     | 0       | +20     | ps   |

Electrical parameters are confirmed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

### 3.6.1 Additive Clock Phase Noise Characteristics

The RC18016 is a buffer device; it does not filter the phase noise on the input clock source. Phase noise caused by noise sources within the device can add to the input signal noise, resulting in an increased noise on the outputs (additive phase noise). Phase noise from within the part is not correlated with the noise on the input; therefore, the root-sum-square method must be used to calculate the output phase noise:  $\Phi_{OUT}^2 = \Phi_{IN}^2 + \Phi_{DEVICE}^2$ . As a consequence, at frequency offsets where the input phase noise  $\Phi_{IN}$  is higher than internal noise sources, the effect of additive phase noise is not measurable.

Simulations of the device phase noise performance are done with an ideal input source; however, simulation models may not account for all possible internal noise sources. Table 16 shows the simulation results for the RC18016 buffers with an ideal input source. Table 17 shows output phase noise measured with a low-noise input source, with one column for the measured data and a second column which de-rates the measured data by a



<sup>2.</sup> ΦCLK\_x clock channel delay unit is equal to 1 ÷ f<sub>IN</sub>

factor to model the process variation. Figure 4, Figure 5, and Figure 6 show that the input phase noise is the dominating factor in the measured data up to an offset of 100kHz. Above 100kHz, the noise floor of the device dominates the characteristics.

Table 16. Additive Clock Phase Noise Characteristics (Simulation [1]),  $V_{DD\ V} = 3.3V \pm 5\%$  [2]

| Symbol                | Param                         | neter     | Test Conditions                           | 25°C   | 85°C, Worst Case | Unit   |
|-----------------------|-------------------------------|-----------|---|--------|------------------|--------|
| Φ <sub>N</sub> (1k)   |                               |           | 1kHz offset from Carrier                  | -146.2 | -145.5           | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                               |           | 10kHz offset from Carrier                 | -156.6 | -155.3           | dBc/Hz |
| Ф <sub>N</sub> (100k) |                               | 245.76MHz | 100kHz offset from Carrier                | -161.9 | -159.6           | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                               |           | 1MHz offset from Carrier                  | -162.4 | -160.5           | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                               |           | 10MHz offset from Carrier and Noise Floor | -162.4 | -160.5           | dBc/Hz |
| Φ <sub>N</sub> (1k)   |                               |           | 1kHz offset from Carrier                  | -141.6 | -141.6           | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                               |           | 10kHz offset from Carrier                 | -152.7 | -151.6           | dBc/Hz |
| Ф <sub>N</sub> (100k) | QCLK_ <i>y</i><br>Phase Noise | 491.52MHz | 100kHz offset from Carrier                | -159.2 | -157.0           | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                               |           | 1MHz offset from Carrier                  | -159.8 | -158.1           | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                               |           | 10MHz offset from Carrier and Noise Floor | -159.9 | -158.2           | dBc/Hz |
| Φ <sub>N</sub> (1k)   |                               |           | 1kHz offset from Carrier                  | -134.5 | -132.0           | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                               |           | 10kHz offset from Carrier                 | -141.4 | -141.8           | dBc/Hz |
| Φ <sub>N</sub> (100k) |                               | 983.04MHz | 100kHz offset from Carrier                | -155.8 | -152.6           | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                               |           | 1MHz offset from Carrier                  | -157.2 | -155.3           | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                               |           | 10MHz offset from Carrier and Noise Floor | -157.2 | -155.8           | dBc/Hz |

<sup>1.</sup> Ideal input signal: rectangular clock signal with a slew rate of 5V/ns and without phase noise.

<sup>2.</sup> Phase noise and spurious specifications apply for device operation with QREF\_r outputs inactive (no SYSREF pulses generated). Phase noise specifications are applicable for all outputs active, Nx not equal, process and voltage variations included.

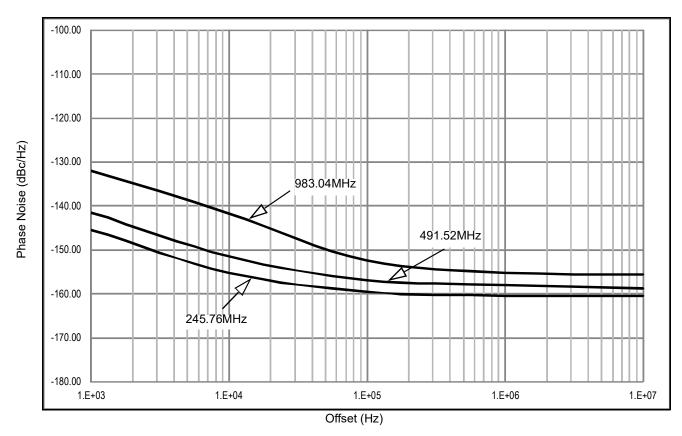


Figure 3. Additive Clock Phase Noise Characteristics (85°C, Worst Case Simulation Model)

Table 17. Additive Clock Phase Noise Characteristics (Measured),  $V_{DD_V} = 3.3V \pm 5\%$ ,  $T_A = -40$ °C to  $\pm 105$ °C [1][2]

| Symbol                | Param                 | eter      | Test Conditions                           | Measured [3] | De-Rated [4] | Unit   |
|-----------------------|-----------------------|-----------|---|--------------|--------------|--------|
| Φ <sub>N</sub> (1k)   |                       |           | 1kHz offset from Carrier                  | -141.4       | -137.2       | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                       |           | 10kHz offset from Carrier                 | -151.7       | -149.5       | dBc/Hz |
| Φ <sub>N</sub> (100k) |                       | 245.76MHz | 100kHz offset from Carrier                | -157.8       | -155.5       | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                       |           | 1MHz offset from Carrier                  | -158.6       | -156.2       | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                       |           | 10MHz offset from Carrier and Noise Floor | -158.8       | -156.3       | dBc/Hz |
| Φ <sub>N</sub> (1k)   |                       |           | 1kHz offset from Carrier                  | -135.3       | -128.4       | dBc/Hz |
| Ф <sub>N</sub> (10k)  |                       |           | 10kHz offset from Carrier                 | -145.8       | -140.5       | dBc/Hz |
| Φ <sub>N</sub> (100k) | QCLK_y<br>Phase Noise | 491.52MHz | 100kHz offset from Carrier                | -154.2       | -149.5       | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                       |           | 1MHz offset from Carrier                  | -157.2       | -155.4       | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                       |           | 10MHz offset from Carrier and Noise Floor | -157.6       | -156.3       | dBc/Hz |
| Φ <sub>N</sub> (1k)   |                       |           | 1kHz offset from Carrier                  | -131.3       | -125.7       | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                       |           | 10kHz offset from Carrier                 | -141.2       | -138.5       | dBc/Hz |
| Φ <sub>N</sub> (100k) |                       | 983.04MHz | 100kHz offset from Carrier                | -149.6       | -146.5       | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                       |           | 1MHz offset from Carrier                  | -154.5       | -152.2       | dBc/Hz |
| Φ <sub>N</sub> (10M)  |                       |           | 10MHz offset from Carrier and Noise Floor | -155.3       | -152.5       | dBc/Hz |
| fiit(QX)              | Clock RMS Phase       | e Jitter  | Integration Range: 1kHz – 61.44MHz        | -            | 100          | fs     |
| <i>t</i> jit(Ø)       | (Random)              |           | Integration Range: 12kHz – 20MHz          | -            | 100          | fs     |

- 1. Phase noise and spurious specifications apply for device operation with QREF\_r outputs inactive (no SYSREF pulses generated). Phase noise specifications are applicable for all outputs active, Nx not equal.
- Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
- 3. Measured results at the maximum temperature of 85°C using an input source with a phase noise characteristics of:
  - 245.76MHz: -143.7dBc/Hz (1kHz offset), -152.5dBc/Hz (10kHz), -160.8dBc/Hz (100kHz), -172.6dBc/Hz (1MHz), -179.5dBc/Hz (10MHz).
  - 491.52MHz: -137.7dBc/Hz (1kHz offset), -147.4dBc/Hz (10kHz), -156.1dBc/Hz (100kHz), -167.6dBc/Hz (1MHz), -170.1dBc/Hz (10MHz).
  - 983.04MHz: -132.5dBc/Hz (1kHz offset), -141.4dBc/Hz (10kHz), -149.9dBc/Hz (100kHz), -161.4dBc/Hz (1MHz), -164.2dBc/Hz (10MHz).
- 4. De-rating factor applied to the characterized data at 85°C to account for worst-case process variation.

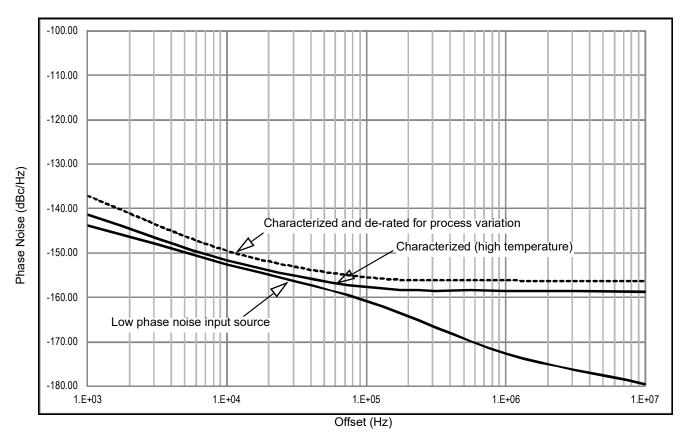


Figure 4. Additive Clock Phase Noise Characteristics (Measured),  $f_{OUT}$  = 245.76MHz

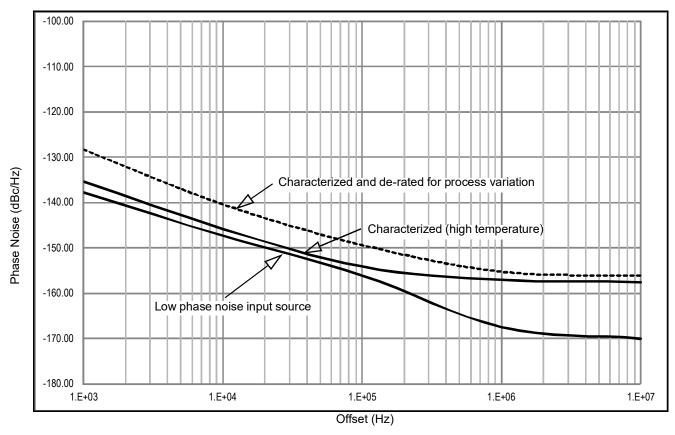


Figure 5. Additive Clock Phase Noise Characteristics (Measured),  $f_{OUT}$  = 491.52MHz

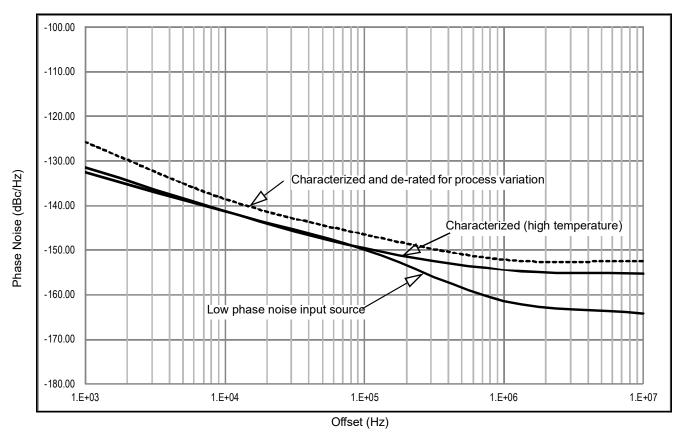


Figure 6. Additive Clock Phase Noise Characteristics (Measured),  $f_{OUT}$  = 983.04MHz

Table 18. SYSREF Phase Noise Characteristics (Measured)

| Symbol                | Parameter        |                            | Test Conditions            | Typical | Units  |
|-----------------------|------------------|----------------------------|----------------------------|---------|--------|
| Φ <sub>N</sub> (1k)   |                  |                            | 1kHz offset from Carrier   | -146    | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                  | 15.36MHz <sup>[1]</sup>    | 10kHz offset from Carrier  | -152.5  | dBc/Hz |
| Φ <sub>N</sub> (100k) |                  | 13.301/172 11              | 100kHz offset from Carrier | -156    | dBc/Hz |
| Φ <sub>N</sub> (1M)   | QREF_r           | r                          | 1MHz offset from Carrier   | -156    | dBc/Hz |
| Φ <sub>N</sub> (1k)   | Phase Noise      |                            | 1kHz offset from Carrier   | -147.5  | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                  | 30.72MHz <sup>[1]</sup>    | 10kHz offset from Carrier  | -153.5  | dBc/Hz |
| Ф <sub>N</sub> (100k) | 30.7 ZIVITIZ 1.1 | 100kHz offset from Carrier | -155.5                     | dBc/Hz  |        |
| Φ <sub>N</sub> (1M)   |                  |                            | 1MHz offset from Carrier   | -155.5  | dBc/Hz |

<sup>1.</sup> Measured results with DLC[1:0] = 00 and  $\Phi$ REF\_r = 3.

## 4. Principles of Operation

#### 4.1 Overview

The RC18016 is a JESD204B/C fanout buffer with configurable phase delay. The device supports the division, phase-delay, and distribution of high-frequency clocks (input: CLK, nCLK), and the fanout and phase-delay of low-frequency synchronization (SYSREF) signals (input: REF/nREF). Clock and SYSREF signal paths are independent and are organized in channels, with each channel consisting of several clock and SYSREF outputs. Outputs are configurable with support for LVPECL, LVDS, and AC-HCSL. Individual channels and unused circuit blocks support a powered-down state for reduced power consumption operation. The register map, accessible through a SPI interface with read-back capability, controls the main device settings.

### 4.2 Signal Flow

The RC18016 offers four channels with the names A, B, C, and D. Each channel supports individual frequency-division, phase-delay and fan-out functions of the input clock to a total of eight QCLK\_y clock outputs; each channel also distributes the SYSREF input signal to multiple QREF\_r outputs with individual per-output phase delay capability.

The central clock distribution ensures low skew clock outputs within each channel; outputs are synchronous across channels (independent on the divider setting) on the incident rising clock edge for all outputs with equal phase delay settings.

SYSREF output are synchronous with each other for equal phase-delay settings. QCLK\_y and QREF\_r outputs will be phase-locked to each other if the CLK and REF inputs are phase-locked. The phase-delay capability in each signal path can be used to establish repeatable and deterministic clock to SYSREF phase relationships at the outputs.

The CLK and QREF signal paths are optimized for channel isolation allowing high-speed clocks of 983.04MHz, 1474.56MHz, or 1966.08MHz (up to 3GHz), and lower-speed SYSREF signals at, e.g., 7.68MHz or 9.6MHz, with a minimum of signal crosstalk and spurious signals.

### 4.3 Clock Channel Divider

Each of the independent frequency dividers  $N_A$ - $N_D$  can be individually set to the divider values  $\div 1$ ,  $\div 2$ ,  $\div 3$ ,  $\div 4$ ,  $\div 6$ ,  $\div 8$ ,  $\div 12$ ,  $\div 16$ , and  $\div 24$ . The dividers are synchronous and have an equal propagation delay on the incident edge (for the supported frequency divider settings, see Table 19). The default (power-up) divider value for channel A and D is  $\div 1$ , the default divider value for channel B and C are set by the state of pin 31 (NBC\_DEF). See Table 20.

| N <sub>A-D</sub> | Clock Divider                         |
|------------------|---------------------------------------|
| 0000             | ÷1<br>Divider bypass and powered down |
| 0001             | ÷2                                    |
| 0010             | ÷3                                    |
| 0011             | ÷4                                    |
| 0100             | ÷6                                    |
| 0101             | ÷8                                    |
| 0110             | ÷12                                   |
| 0111             | ÷16                                   |
| 1000             | ÷24                                   |

Table 19. N<sub>A-D</sub> Frequency Divider Settings

| Divider                         | Default Clo | ock Divider     |
|---------------------------------|-------------|-----------------|
| Divider                         | NBC_DEF = 0 | NBC_DEF = 1 [1] |
| N <sub>A</sub> , N <sub>D</sub> | ÷           | 1               |
| N <sub>B</sub> , N <sub>C</sub> | ÷3          | ÷4              |

**Table 20. Frequency Divider Default Settings** 

### 4.4 Phase Delay

Output phase delay is independently supported on each clock channel and each SYSREF output. The delay unit of the clock channel phase-delay circuits  $\Phi_{CLK}$  is a function of the frequency  $f_{IN}$  applied to CLK input:  $1 \div f_{IN}$ .

The delay unit of the SYSREF phase-delay circuits  $\Phi_{REF\_r}$  is a function of an internal oscillator frequency  $f_{DCO}$  and the DLC multiplier setting. The oscillator is fully self-contained and located in delay calibration block (DCB). At startup, this oscillator is calibrated with the input frequency  $f_{IN}$  as reference. After the calibration, the oscillator is turned-off to save power and to eliminate noise. See Table 21 for details on the delay unit, number of available steps and the delay range.

| Delay Circuit                    | Unit   | Steps | Range  |
|----------------------------------|--|-------|--|
| Clock channel Φ <sub>CLK_x</sub> | 1 ÷ f <sub>IN</sub><br>1.017ns at f <sub>IN</sub> = 983.04MHz        | 256   | 256 ÷ f <sub>IN</sub> <sup>[1]</sup><br>0 to 259.3ns at f <sub>IN</sub> = 983.04MHz              |
|                                  | T <sub>DCB</sub> <sup>[2]</sup>                                      |       | 07 * T <sub>DCB</sub> <sup>[3]</sup>   |
| SYSREF $\Phi_{REF\_r}$           | DLC = 0: 131ps<br>DLC = 1: 262ps<br>DLC = 2: 393ps<br>DLC = 3: 524ps | 8     | DLC = 0: 0 to 0.917ns<br>DLC = 1: 0 to 1.834ns<br>DLC = 2: 0 to 2.751ns<br>DLC = 3: 0 to 3.668ns |

**Table 21. Delay Circuit Characteristics** 

### 4.4.1 Delay Calibration Block (DCB)

The DCB sets the SYSREF delay unit by providing a reference signal to the QREF\_r delay circuits. Figure 7 shows the functional diagram. The DCB requires configuration and calibration. Verification of the calibration is optional.

**Description**: The DCB consists of an internal DCO running at  $f_{DCO}$  = 983.04 ±20MHz, three frequency dividers  $P_{DCB}$ ,  $M_{DCB}$  and  $N_{DCB}$  and a digital hold circuit. The DCB input frequency is the device input frequency  $f_{IN}$  at the differential CLK, nCLK input. The input frequency acts as a reference to lock the oscillator to a stable and known frequency.

The output of the DCB is the effective delay unit  $T_{DCB}$  which is approximately one eighth of the oscillator period multiplied by the DLC multiplier. The DLC multiplier extends the delay unit by a factor of 1, 2, 3 or 4. For instance, at a DCO frequency of 983.04MHz, DLC = 1 sets the SYSREF delay unit to 131ps; DLC = 2 sets the delay unit to 262ps, etc.

**Configuration**: Select a desired delay unit and corresponding DLC multiplier from Table 22. DLC[1:0] also sets the  $N_{DCB}$  divider. Then, find a  $P_{DCB}$  and  $M_{DCB}$  divider configuration to locate the oscillator frequency into the range of  $f_{DCO}$  = 983.04MHz according to the formula in Figure 7. The DCO lock condition is  $f_1$  =  $f_2$  while both  $f_1$  and  $f_2$  must be lower than 200MHz. For instance, if  $f_{IN}$  = 245.76MHz and the smallest possible SYSREF delay unit is desired, set DLC = 1 (DLC[1:0] = 00; also sets  $N_{DCB}$  = ÷1). Then, set  $P_{DCB}$  = ÷24 and  $M_{DCB}$  = ÷96. As a result,



<sup>1.</sup> NBC DEF can be left open (reads logic 1).

<sup>1.</sup> At f<sub>IN</sub> = 983.04MHz, the clock channel delay range is equal to 260.416ns and encompasses 32 periods of a 122.88MHz clock signal.

<sup>2.</sup>  $T_{DCB} \sim DLC \div (8 \cdot f_{DCO})$ .  $f_{DCO} = 983.04 MHz$ . DLC = 1, 2, 3 or 4.

<sup>3.</sup> SYSREF phase delay supports ≥ 8 delay stops within one input reference period for f<sub>IN</sub> = 254.76MHz to f<sub>IN</sub> = 983.04MHz.

 $f_1 = f_2 = 10.24$ MHz,  $f_{DCO} = 983.04$ MHz. This example configuration results in a delay unit of measured: 131ps. Table 23 shows more configuration examples.

**Calibration**: Calibration requires a valid DCB configuration with the DCO locking to an input frequency. Setting DCB\_CAL = 1 starts an automatic calibration. At the end, the DCB\_CAL bit will clear, the delay unit value is stored digitally and the DCO,  $P_{DCB}$ ,  $M_{DCB}$  and  $N_{DCB}$  frequency dividers turn off. The QREF\_r delay circuits now use the stored constant delay unit. The delay unit remains digitally stored until the next power cycle. The DCB calibration must run once as part of the device startup procedure and must be re-run after each input frequency or DCB configuration change.

**Verification**: Verify a successful calibration by reading the DAC\_CODE value.  $0 < DAC_CODE < 32767$  indicates a successful calibration. If DAC\_CODE = 0 or DAC\_CODE = 32767, the DCB calibration should be re-run with an alternative  $P_{DCB}$ ,  $M_{DCB}$  setting while maintaining the desired  $M_{DCB} \cdot N_{DCB}/P_{DCB}$  ratio for locking the DCO to the input frequency.

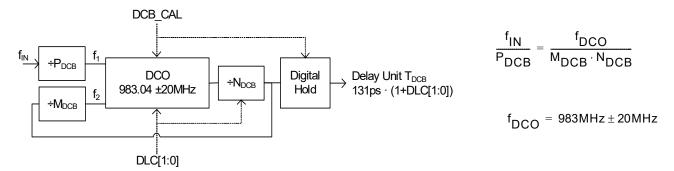


Figure 7. DCB Functional Diagram

Table 22. DCB Delay Unit at f<sub>DCO</sub> = 983.04MHz

| T <sub>DCB</sub> | Γ                | N             |                  |  |
|------------------|------------------|---------------|------------------|--|
| Delay Unit (ps)  | DLC[1:0] Setting | Numeric Value | N <sub>DCB</sub> |  |
| 131              | 00               | 1             | 1                |  |
| 262              | 01               | 2             | 2                |  |
| 393              | 10               | 3             | 3                |  |
| 524              | 11               | 4             | 4                |  |

Table 23. DCB Divider Configuration Examples [1]

| f <sub>IN</sub> (MHz) | T <sub>DCB</sub><br>Delay Unit in ps | DLC | P <sub>DCB</sub> | M <sub>DCB</sub> |
|-----------------------|--------------------------------------|-----|------------------|------------------|
|                       | 131                                  | 1   | 24               | 96               |
| 245.76                | 262                                  | 2   | 24               | 48               |
| 245.76                | 393                                  | 3   | 24               | 32               |
|                       | 524                                  | 4   | 24               | 24               |
|                       | 131                                  | 1   | 48               | 96               |
| 491.52                | 262                                  | 2   | 48               | 48               |
| 491.52                | 393                                  | 3   | 48               | 32               |
|                       | 524                                  | 4   | 48               | 24               |
|                       | 131                                  | 1   | 96               | 96               |
| 002.04                | 262                                  | 2   | 96               | 48               |
| 983.04                | 393                                  | 3   | 96               | 32               |
|                       | 524                                  | 4   | 96               | 24               |

<sup>1.</sup>  $f_{DCO} = 983.04MHz$ .



## 4.5 QCLK\_y to SYSREF Phase Alignment

**Single Device**: To achieve an output phase alignment between the QCLK\_y clock and the QREF\_r SYSREF outputs, the CLK and REF input signals must be phase aligned or have a known, deterministic phase relationship. Figure 8 shows an example output phase alignment for aligned clock and SYREF inputs. The closest (smallest phase error) output alignment is achieved by setting the clock phase delay register  $\Phi_{QCLK\_Y}$  to 0x00 (clock) and the SYSREF phase delay register  $\Phi_{QCLK\_Y}$  to 0x04. With a SYSREF phase delay setting of 0x03 or less, the QREF\_r output phase is in advance of the QCLK\_y phase, which is applicable in JESD204B/C application. Phase delay settings and propagation delays are independent on the clock and SYSREF frequencies. Table 24 shows recommended phase delay setting several device configurations.

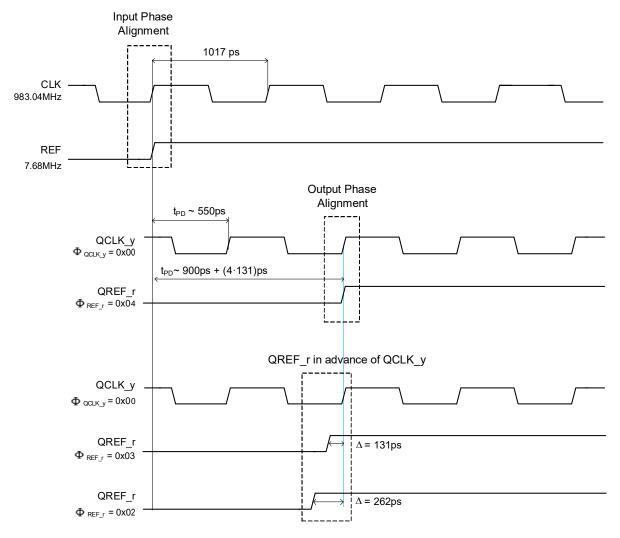


Figure 8. QCLK\_y to QREF Phase Alignment

Table 24. Recommended Delay Settings for Closest Clock-SYSREF Output Phase Alignment [1]

| Divider Configuration | Ф <b>СLK_y</b> | ΦREF_r |  |
|-----------------------|----------------|--------|--|
| N = ÷1                | 0x00           | 0x04   |  |

<sup>1.</sup> QCLK\_y and QREF outputs are aligned on the incident edge.

### 4.5.1 QCLK y and QREF r Phase Alignment Across Multiple Devices

The device architecture supports phase aligned QCLK\_y and QREF\_r output signals across multiple devices. For applications that use the frequency dividers of  $\div 2$ ,  $\div 3$ ,  $\div 4$ ,  $\div 6$ ,  $\div 8$ ,  $\div 12$ ,  $\div 16$ , or  $\div 24$ , or any combination of these

dividers, all devices participating in the output phase alignment must go through a specific alignment procedure at device startup.

#### Pre-conditions

- Each RC18016 must be driven by a clock device that keeps clock and SYSREF signals aligned at the CLK and REF inputs (see setup and hold time specification).
- The frequency on the REF input must be smaller than any QCLK\_y output frequency.
- A valid input frequency must be applied to the CLK input (e.g., 491.52MHz).

#### Alignment Method

- Phase alignment is achieved by driving the REF inputs with a rising edge signal at the same time with respect
  to the CLK input signal.
- During the alignment process, the output period of the divided clock signal (on QCLK\_y outputs) will have longer periods until output alignment is achieved.
  - Example: Input CLK frequency is 491.52MHz, output divider is ÷4, output frequency is 122.88MHz. During the alignment procedure started by REF, the QCLK\_y output period changes from 8.138ns to 10.172ns for multiple cycles. The device facilitates the period of the input signal (2.034ns) to "stretch" the output period: 8.138ns + 2.034ns = 10.172ns.

#### Alignment Procedure

- 1. Set the MD\_ALIGN\_Φ bit to enable the alignment procedure.
  - Wait for ≥ 5µs before applying a signal to the REF input.
- 2. Apply an alignment signal (rising edge) to the REF input.
  - Place the rising edge REF signal before the rising edge of the CLK signal that is shared between all participating buffers.
  - REF to CLK setup and hold time specification must be met.
  - A single REF rising edge is sufficient for starting the alignment.
- 3. Output behavior during alignment:
  - QCLK y outputs in ÷1 divider mode work normally as expected without cycle slips or period increases.
  - QCLK\_y outputs in ÷2, ÷3, ÷4, ÷6, ÷8, ÷12, ÷16 or ÷24 divider mode expose longer periods as described above.
  - REF outputs always buffer out the REF input signal (when QREF\_r outputs are powered on and are enabled).

#### Result

- The procedure aligns the output phases (rising incident edge) of all QCLK\_y output signals across participating buffers. This includes the output phases of the frequency-divided clock signals and the outputs divided by 1.
- The input to output delay is the same across all participating buffer devices (measured on the incident edge).
- The alignment procedure has a maximum duration of 48x (1 ÷ f<sub>IN</sub>).
- After alignment is achieved, the device auto-clears the MD\_ALIGN\_Φ register bit.

The alignment procedure can be repeated at any time after setting the MD ALIGN Φ bit.

Table 25. MD\_ALIGN\_Φ Multi-Device Phase Alignment Function Table

| MD_ALIGN_Φ  | Operation  | Comment   |  |  |
|-------------|--|---|--|--|
| 0 (default) | Multi-buffer phase alignment is disabled.                                      | SYSREF signals at the REF input are buffered out to the SYSREF outputs when output buffers are enabled.   |  |  |
| 1           | A rising edge at the REF input will start an output phase alignment procedure. | Requires a valid clock signal at the CLK input. REF to CLK setup and hold time specifications have to be met. This bit auto-clears after alignment is achieved. |  |  |



### 4.6 Differential Outputs

**Table 26. Output Features** 

| Output                         | Туре                    | Amplitude [1]         | Disable | Power Down | DC Bias            | Termination                         |                                     |
|--------------------------------|-------------------------|-----------------------|---------|------------|--------------------|-------------------------------------|-------------------------------------|
| QCLK <i>y</i> <sup>[2]</sup> , | LVPECL                  | 350–1000mV<br>3 steps |         |            | _                  | $50\Omega$ to $V_T^{[4]}$           |                                     |
| QREF_r [3]<br>(Clock)          | LVDS                    | 350, 750mV<br>2 steps | Yes     | Yes        | Yes                | -                                   | 100Ω differential <sup>[5][6]</sup> |
|                                | AC-HCSL [7]             | 500mV                 |         |            | Yes                | $50\Omega$ to ground                |                                     |
| 0.055                          | LVPECL                  | 350-1000mV<br>3 steps |         |            | -                  | $50\Omega$ to $V_T^{[4]}$           |                                     |
| QREF_ <i>r</i><br>(SYSREF)     | LVDS 350, 750mV 2 steps |                       | Yes     | Yes        | Yes <sup>[8]</sup> | 100Ω differential <sup>[5][6]</sup> |                                     |
|                                | AC-HCSL [7]             | 500mV                 |         |            | Yes                | $50\Omega$ to ground                |                                     |

- 1. Amplitudes are measured single-ended. Differential amplitudes supported are 700mV, 1500mV and 2000mV.
- 2. y = A0, A1, A2, B0, B1, C0, C1, D.
- 3. r = A0, A1, A2, B0, B1, C0, C1, D.
- $4. \quad V_T = V_{DD\ V} 1.6V \ (350 mV \ amplitude\ setting), \ V_{DD\ V} 2.0V \ (750 mV \ amplitude\ setting), \ V_{DD\ V} 2.25V \ (1000 mV \ amplitude\ setting).$
- 5. AC coupling and DC coupling supported.
- 6. See Application Information for output termination information.
- 7. AC-HCSL refers to an output type with voltage levels below 1.2V and AC characteristics similar to HCSL.
- 8. In JESD204B/C applications, it is recommended to use QREF\_r (SYSREF) outputs configured to LVDS and 350mV amplitude. AC-coupling and DC-coupling is supported.

Table 27. Individual Clock Output (QCLK\_y) Settings [1]

| PD | HSTL | STYLE | EN | A[1:0] | Output Power | Termination <sup>[2]</sup>                        | State       | Amplitude (mV) |     |
|----|------|-------|----|--------|--------------|---|-------------|----------------|-----|
| 1  | Х    | Х     | Х  | Х      | Off          | $100\Omega$ differential (LVDS) or no termination | Off         | Х              |     |
|    |      |       | 0  | XX     |              |   | Disable [3] | Х              |     |
| 0  | 0    | 0     | 1  | 00     | On           | 100 $\Omega$ differential (LVDS)                  | Enable      | 350            |     |
|    |      |       | ı  | 01     | 01           |   | Lilable     | 750            |     |
|    |      |       | 0  | XX     |              |   | Disable     | Х              |     |
|    |      |       |    | 00     |              |   |             |                | 350 |
| 0  | 0    | 1     | 1  | 01     | On           | $50\Omega$ to V <sub>T</sub> (LVPECL)             |             | 750            |     |
|    |      |       | ı  | 10     |              |   | Enable      | 1000           |     |
|    |      |       |    | 11     |              |   |             | 1000           |     |
| 0  | 1    | 1     | 0  | Х      | On           | 50Ω to ground (AC-HCSL)                           | Disable     | Х              |     |
| 0  | '    | 1     | 1  | _ ^    | Oil          | 3052 to ground (AC-HOSE)                          | Enable      | 500            |     |

- 1. Applicable to clock outputs: QCLK $_y$  and QREF $_r$  outputs in clock mode (MUX $_r$  = 0).
- 2. See Application Information for output termination information.
- 3. Differential output is disabled in static low state: QCLK $_y$  = L, nQCLK $_y$  = H.

| Table 28. Individual SYSREF Output (QREF_r) Settings [1] | Table 28 | . Individual SY | SREF Output | (QREF r | Settinas [1 |
|--|----------|-----------------|-------------|---------|-------------|
|--|----------|-----------------|-------------|---------|-------------|

| PD | HSTL | STYLE | EN | A[1:0]                            | BIAS<br>_TYP<br>E | Output Power | Termination <sup>[2]</sup>                 | State           | Amplitude (mV) |
|----|------|-------|----|-----------------------------------|-------------------|--------------|--|-----------------|----------------|
| 1  | Х    | Х     | Х  | Х                                 | Х                 | Off          | $100\Omega$ differential or no termination | Off             | Х              |
|    |      |       | 0  | XX                                | 0                 |              |  | Disable [3]     | Х              |
|    |      |       |    | 00                                | 0                 |              |  | Enabled         | 350            |
| 0  | 0    | 0     | 1  | 01                                | 0                 | On           | 100 $\Omega$ differential (LVDS)           | See<br>Table 29 | 750            |
|    |      |       |    |                                   | 1                 |              |  | Enabled         |                |
|    |      |       | 0  | XX                                |                   |              |  | Disable         | Х              |
|    |      |       |    | 00                                |                   |              |  |                 | 350            |
| 0  | 0 1  |       | 1  | 0 On $50\Omega$ to $V_T$ (LVPECL) | 0                 | Enable 7     | 750  |                 |                |
|    |      |       | 1  | 10                                |                   |              |  | Enable          | 1000           |
|    |      |       |    | 11                                |                   |              |  |                 | 1000           |
| 0  | 1    | 1     | 0  | Х                                 | 0                 | On           | 500 to ground (AC HCSI.)                   | Disable         | X              |
|    |      |       | 1  |                                   | U                 | On           | $50\Omega$ to ground (AC-HCSL)             | Enable          | 500            |

- 1. Applicable QREF\_r outputs when configured as SYSREF output (MUX\_r = 1).
- 2. See Application Information for output termination information.
- 3. Differential output is disabled in static low state: QCLK y = L, nQCLK y = H.

Table 29. QREF\_r Setting for JESD204B/C Applications

|                  |   |                                     | QREF_r Outputs (LVDS)                                    |  |                              |
|------------------|---|-------------------------------------|--|--|------------------------------|
| BIAS_TYPE BIAS_r |   | Initial                             | Active Rising Edge on the REF Input                      | SYSREF Completed   | Application                  |
| 0                | 0 | Static low [1]                      | Start switching for the number of received SYSREF pulses | Released to static low [1]   | QREF_r DC coupled            |
|                  | 1 |                                     | Static low <sup>[1]</sup>                                |  | DC coupled                   |
| 1                | 0 | Static LVDS crosspoint level [2][3] | Start switching for the number of received SYSREF pulses | Released to static low [1] or static high [4], matching the final state of the REF input | QREF_ <i>r</i><br>AC coupled |
|                  | 1 | Static LVDS crosspoint level [2][3] |  |  |                              |

- 1.  $QREF_r = L$ ,  $nQREF_r = H$ .
- 2.  $QREF_r = nQREF_r = VOS$ .
- 3. This is the state after setting the PD\_S bit to 1 and then setting it to 0 as described in step 3 of Device Startup, Reset, and Synchronization.
- 4.  $QREF_r = H$ ,  $nQREF_r = L$ .

## 4.7 Device Startup, Reset, and Synchronization

At startup, an internal POR (power-on reset) resets the RC18016 and sets all register bits to its default value. The default divider value of the NB and NC frequency dividers are set by the state of the NBC\_DEF pin. After internal POR, the device will initialize internal circuits and for 2ms before it accepts an external clock signal at the CLK input (the CLK input is internally turned off during that time).

In the default configuration the QCLK\_y outputs are enabled, QREF outputs are disabled at startup. Recommended configuration sequence (in order):

- 1. (Optional) Set the value of the CPOL register bit to define the SPI read mode so that SPI settings can be validated by subsequent SPI read accesses.
- Verify the completion of internal power-up by reading the ST\_READY status bit in register 0x6E, bit D1.
   ST\_READY is set to 1 by the device at the end of the internal power-up procedure. Continue the device startup once ST\_READY is set to 1.

- 3. Configure the channel circuits and the outputs to the desired values and configure the DCB:
  - For synchronization between multiple devices (see QCLK\_y and QREF\_r Phase Alignment Across Multiple Devices). Write a 1 to MD\_ALIGN\_ Φ to start the multi-buffer phase alignment process. This will cause the st\_any\_ALIGN status bit to be set to 1, then the MD\_ALIGN\_ Φ bit will automatically clear. The st\_any\_ALIGN status bit can be used to monitor the multi-buffer alignment process. When st\_any\_ALIGN reports 1, the device is either waiting for a rising edge on REF, or the alignment is in progress. When st\_any\_ALIGN reports 0, the alignment is complete. The multi-device alignment requires a valid clock signal to be applied to the CLK input.
  - Output source MUX\_r, output divider N<sub>A-D</sub>, clock delay Φ<sub>A-D</sub>; MUX-output style, amplitude and power down
    mode for QCLK\_y and QREF\_r outputs
  - (Optional) In preparation for JESD204B/C SYSREF operation, configure the global BIAS\_TYPE bit and the BIAS\_r bit for each QREF\_r. Further, for AC coupling applications (BIAS\_TYPE = 1) after setting BIAS\_TYPE to 1, set the PD\_S bit to 1 and then set it to 0; this will set QREF\_r and nQREF\_r to the LVDS crosspoint level (VOS). If SYSREF generation is started and halted, then repeat the process of setting the PD\_S bit to 1 and then setting it to 0; this will set QREF\_r and nQREF\_r to the LVDS crosspoint level (VOS).
  - Phase delay for Φ<sub>REF r</sub> values for the QREF\_r outputs.
  - Setup the DCB settings DLC, P<sub>DCB</sub> and M<sub>DCB</sub> as described in the paragraph "Configuration", see Delay Calibration Block (DCB)
- 4. If not already applied: apply a valid input frequency to CLK. Set the PB\_CAL bit and the DCB\_CAL bit to start the calibration of the precision bias current circuit and the DCB calibration. Both bits will auto-clear. See paragraph "Configuration" in Delay Calibration Block (DCB).
  - (Optional): verify the success of the DCB calibration by reading the DAC\_CODE value. See paragraph "Verification" in Delay Calibration Block (DCB)
- 5. (Only for using the clock delay circuits): Set the initialization bit INIT\_CLK to initiate the ΦCLK\_x delay circuits. The INIT\_CLK bit will self-clear. During this initialization step, all QCLK\_y and QREF\_r outputs are reset to the logic low state.
- 6. Enable or disable outputs as desired by accessing the output-enable registers 0x74 and 0x76.
- 7. At this point, the configuration of the registers should be completed and the SPI transfer ended. Set nCS to high level.

Registers in the address range 0x78 to 0xFF should not be used. Do not write into any registers in the 0x78 to 0xFF range.

### 4.7.1 Changing Frequency Dividers and Phase Delay Values

### **Clock Frequency Divider and Delay**

The following procedure must be applied for a change of a clock divider and phase delay value  $N_{A-D_1}$  and  $\Phi_{CLKA-D_2}$ :

- (Optional) Set the value of the CPOL register to define the SPI read mode so that SPI settings can be validated by subsequent SPI read accesses.
- 2. (Optional) Disable outputs that will experience a frequency divider or delay value change.
- 3. Configure the  $N_{A-D}$  dividers and the delay circuits  $\Phi_{CLKA-D}$  to the desired new values.
- 4. Set the initialization bit INIT\_CLK. This will initiate all divider and delay circuits, and synchronize them to each other. The INIT\_CLK bit will self-clear. During this initialization step, all QCLK\_y and QREF\_r outputs are reset to the logic low state.
- 5. (Optional) Enable the outputs whose frequency divider was changed.



#### SYSREF Delay

The following procedure must be applied for a change of any SYSREF phase delay value Φ<sub>REF</sub> r:

- (Optional) Set the value of the CPOL register to define the SPI read mode so that SPI settings can be validated by subsequent SPI read accesses.
- 2. Configure any delay circuits  $\Phi_{\mathsf{REF}\_r}$  to their desired new values. During configuration of  $\Phi_{\mathsf{REF}\_r}$  outputs are not stopped or interrupted.

#### 4.8 SPI Interface

The RC18016 has a 3-wire serial control port capable of responding as a slave in an SPI configuration to allow read and write access to any of the internal registers for device programming or read back. The SPI interface consists of the SCLK (clock), SDAT (serial data input and output), and nCS (chip select) pins. A data transfer consists of any integer multiple of 8 bits and is always initiated by the SPI master on the bus. Internal register data is organized in SPI bytes of 8 bits each. If nCS is at logic high, the SDAT data I/O is in high-impedance state and the SPI interface of the RC18016 is disabled. In a write operation, data on SDAT will be clocked in on the rising edge of SCLK. In a read operation, data on SDAT will be clocked out on the falling or rising edge of SCLK depending on the CPOL setting (CPOL = 0: output data changes on the falling edge, CPOL = 1: output data changes on the rising edge).

**Starting a data transfer:** Requires nCS to set and hold at logic low level during the entire transfer. Setting nCS = 0 will enable the SPI interface with SDAT in data input mode. The master must initiate the first 8-bit transfer. The first bit presented to the slave is the direction bit R/nW (1 = Read, 0 = Write) and the following seven bits are the address bits A[0:6] pointing to an internal register in the address space 0 to 127. Data is presented with the LSB (least significant bit) first.

**Read operation:** Read from an internal register. A read operation starts with an 8-bit transfer from the master to the slave. SDAT is clocked on the rising edge of SCLK. The first bit is the direction bit R/nW which must be to 1 to indicate a read transfer, followed by 7 address bits A[0:6]. After the first 8 bits are clocked into SDAT, the SDAT I/O changes to output: the register content addressed by A[0:6] is loaded into the shift register and the next 8 SCLK falling clock cycles (if CPOL = 0) will then present the loaded register data on the SDAT output and transfer these to the master. Transfers must be completed by de-asserting nCS after any multiple 8 SCLK cycles. If nCS is deasserted at any other number of SCLKs, the SPI behavior is undefined. SPI byte (8 bit) and back-to-back read transfers of multiple registers are supported with an address auto-increment. During multiple transfers, nCS must stay at logic low level and SDAT will present multiple registers (A), (A+1), (A+2), etc. with each 8 SCLK cycles. During SPI Read operations, the user may continue to hold nCS low and provide further bytes in a single block read.

Write operation: Write to an RC18016 register. During a write transfer, a SPI master transfers one or more bytes of data into the internal registers of the RC18016. A write transfer starts by asserting nCS to low logic level. The first bit presented by the master must set the direction bit R/nW to 0 (Write) and the 7 address bits A[0:6] must contain the 7-bit register address. Bits D0 to D7 contain 8-bit of payload data, which is written into the register addressed by A[0:6] at the end of a 8-bit write transfer. Multiple, subsequent register transfers from the master to the slave are supported by holding nCS asserted at logic low level during write transfers. The 7-bit register address will auto-increment. Transfers must be completed by de-asserting nCS after any multiple 8 SCLK cycles. If nCS is de-asserted at any other number of SCLKs, the SPI behavior is undefined.

**End of transfer:** After de-asserting nCS, the SPI bus is available to transfers to other slaves on the SPI bus. See also the READ diagram (Figure 9) and WRITE diagram (Figure 10) displaying the transfer of two bytes of data from and into registers.

**Registers 0x78 to 0xFF:** Registers in the address range 0x78 to 0xFF should not be used. Do not write into any registers in this range.



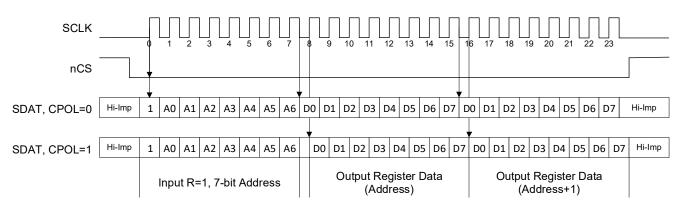


Figure 9. Logic Diagram: READ Data from RC18016 Registers for CPOL = 0 and CPOL = 1

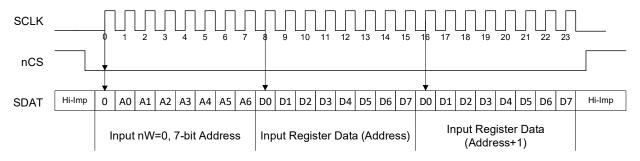


Figure 10. Logic Diagram WRITE Data into RC18016 Registers

Table 30. SPI Read / Write Cycle Timing Parameters

| Symbol            | Parameter                                  | Test Condition | Minimum | Maximum | Unit |
|-------------------|--|----------------|---------|---------|------|
| f <sub>SCLK</sub> | SCLK frequency                             | -              | -       | 20      | MHz  |
| t <sub>S1</sub>   | Setup time, nCS (falling) to SCLK (rising) | -              | 5       | -       | ns   |
| t <sub>S2</sub>   | Setup time, SDAT (input) to SCLK (rising)  | -              | 5       | -       | ns   |
| t <sub>S3</sub>   | Setup time, nCS (rising) to SCLK (rising)  | -              | 5       | -       | ns   |
| t <sub>H1</sub>   | Hold time, SCLK (rising) to SDAT (input)   | -              | 5       | -       | ns   |
| t <sub>H2</sub>   | Hold time, SCLK (falling) to nCS (rising)  | -              | 5       | -       | ns   |
| t <sub>PD1F</sub> | Propagation delay, SCLK (falling) to SDAT  | CPOL = 0       | -       | 12      | ns   |
| t <sub>PD1R</sub> | Propagation delay, SCLK (rising) to SDAT   | CPOL = 1       | -       | 12      | ns   |
| t <sub>PD2</sub>  | Propagation delay, nCS to SDAT disable     | -              | -       | 12      | ns   |
| t <sub>R, F</sub> | Rise, Fall Time, SPI Inputs SCLK, SDAT     | -              | 1       | 10      | ns   |

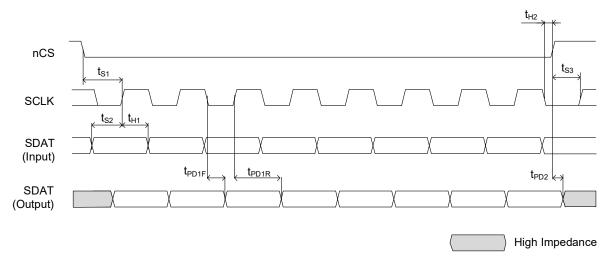


Figure 11. SPI Timing Diagram

## 5. Application Information

### 5.1 Fail-safe Inputs

The CLK/nCLK, REF/nREF, VTC, VTR, and NBC\_DEF pins are fail-safe, meaning they tolerate being driven when the device is powered down.

### 5.2 Input Interface Circuits

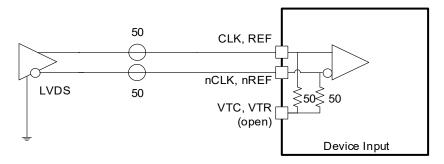


Figure 12. LVDS Output Drives RC18016 Input with Integrated Termination Resistor (DC-Coupled)

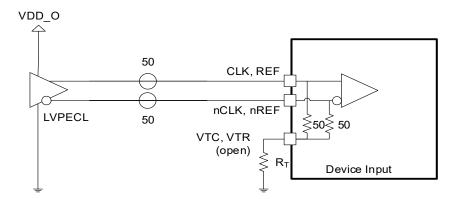


Figure 13. LVPECL Output Drives RC18016 Input with Integrated Termination Resistor (DC-Coupled)

**Table 31. Termination Resistors** 

|                | V <sub>DD_O</sub> = 2.5V | $V_{DD_O} = 3.3V$ |
|----------------|--------------------------|-------------------|
| R <sub>T</sub> | 18Ω                      | 50Ω               |

## 5.3 Termination for QCLK\_y, QREF\_r LVDS Outputs

Figure 14 shows an example termination for the QCLK\_y, QREF\_r LVDS outputs. In this example, the characteristic transmission line impedance is  $50\Omega$ . The termination resistor R ( $100\Omega$ ) is matched to the line impedance. The termination resistor must be placed at the line end. No external termination resistor is required if R is an internal part of the receiver circuit. The LVDS termination in Figure 14 is applicable for any output amplitude setting specified in Table 26.

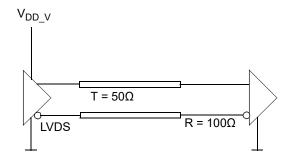


Figure 14. LVDS Output Termination

## 5.4 AC Termination for QCLK\_y, QREF\_r LVDS Outputs

Figure 15 and Figure 16 show example AC terminations for the QCLK\_y, QREF\_r LVDS outputs. In the examples, the characteristic transmission line impedance is  $50\Omega$ . In Figure 15, the termination resistor R ( $100\Omega$ ) is placed at the line end. No external termination resistor is required if R is an internal part of the receiver circuit, which is shown in Figure 16. The LVDS terminations in both Figure 15 and Figure 16 are applicable for any output amplitude setting specified in Table 26. The receiver input should be re-biased according to its common mode range specifications.

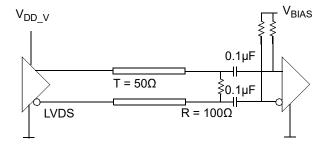


Figure 15. LVDS AC Output Termination - with Rebiased input

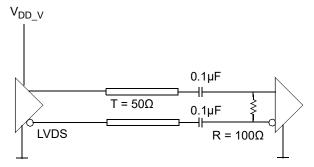


Figure 16. LVDS AC Output Termination

### 5.5 Termination for QCLK\_y, QREF\_r LVPECL Outputs

Figure 17 shows an example termination for the QCLK\_y, QREF\_r LVPECL outputs. In this example, the characteristic transmission line impedance is  $50\Omega$ . The R1 ( $50\Omega$ ) and R2 ( $50\Omega$ ) resistors are matched load terminations. The output is terminated to the termination voltage  $V_T$ . The  $V_T$  must be set according to the output amplitude setting defined in Table 26. The termination resistors must be placed close at the line end.

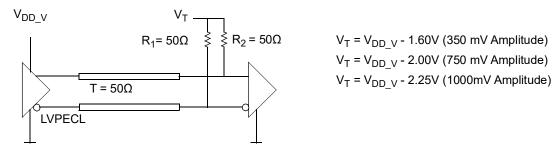


Figure 17. LVPECL Output Termination

### 5.6 Termination for QCLK\_y, QREF\_r AC-HCSL Outputs

Figure 18 shows an example termination for the QCLK\_y, QREF\_r AC-HCSL outputs. In this example, the transmission line is less than 10cm long and the characteristic transmission line impedance is  $50\Omega$ . The R1 ( $50\Omega$ ) and R2 ( $50\Omega$ ) resistors are matched load terminations. For transmission lines longer than 10cm, R1 ( $50\Omega$ ) and R2 ( $50\Omega$ ) should be located close to the driver.

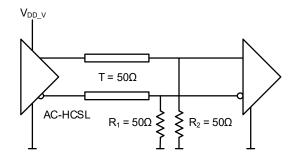


Figure 18. AC-HCSL Output Termination

## 5.7 AC Termination for QCLK\_y, QREF\_r AC-HCSL Outputs

Figure 19 shows an example AC termination for the QCLK\_y, QREF\_r AC-HCSL outputs. In this example, the transmission line is less than 10cm long and the characteristic transmission line impedance is  $50\Omega$ . The R1 ( $50\Omega$ ) and R2 ( $50\Omega$ ) resistors are matched load terminations. For transmission lines longer than 10cm, R1 ( $50\Omega$ ) and R2 ( $50\Omega$ ) should be located close to the driver. The receiver input should be re-biased according to its common mode range specifications.

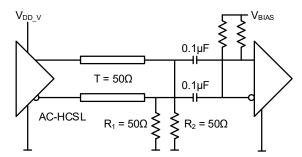


Figure 19. AC-HCSL Output Termination

### 5.8 Package Exposed Pad Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in Figure 20. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13 mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern.

*Note*: These recommendations are to be used as a guideline only. For further information, refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/Electrically Enhance Lead-frame Base Package, Amkor Technology.

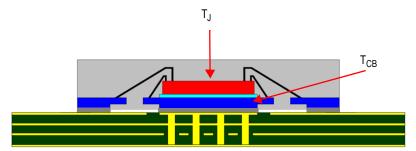


Figure 20. Assembly for Exposed Pad Thermal Release Path - Side View (Drawing not to Scale)

#### 5.8.1 Case Temperature Considerations

The device supports applications in a natural convection environment that does not have any thermal conductivity through ambient air. The printed circuit board (PCB) is typically in a sealed enclosure without any natural or forced air flow and is kept at or below a specific temperature. The device package design incorporates an exposed pad (ePad) with enhanced thermal parameters which is soldered to the PCB where most of the heat escapes from the bottom exposed pad. For this type of application, it is recommended to use the junction-to-board thermal characterization parameter  $\Psi_{JB}$  (Psi-JB) to calculate the junction temperature (T<sub>J</sub>) and ensure it does not exceed the maximum allowed operating junction temperature listed in Absolute Maximum Ratings.

The junction-to-board thermal characterization parameter,  $\Psi_{JB}$  is calculated using the following equation:

$$T_J = T_{CB} + \Psi_{JB} \times P_{D.}$$
 where:

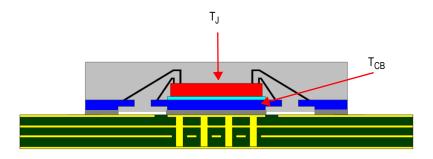
 $T_J$  = Junction temperature at steady state condition in (°C).

T<sub>CB</sub> = Case temperature (Bottom) at steady state condition in (°C).

 $\Psi_{JB}$  = Thermal characterization parameter to report the difference between junction temperature and the temperature of the board measured at the top surface of the board.

 $P_D$  = Power dissipation (W) in desired operating configuration.





The ePad provides a low thermal resistance path for heat transfer to the PCB and represents the key pathway to transfer heat away from the IC to the PCB. It is critical that the connection of the exposed pad to the PCB is properly constructed to maintain the desired IC case temperature  $(T_{CB})$ . A good connection ensures that temperature at the exposed pad  $(T_{CB})$  and the board temperature  $(T_{B})$  are relatively the same. An improper connection can lead to increased junction temperature, increased power consumption and decreased electrical performance. In addition, there could be long-term reliability issues and increased failure rate.

### 5.8.2 Example Calculation for Junction Temperature

The following table is an example calculation for Junction Temperature (T<sub>J</sub>): T<sub>J</sub> = T<sub>CB</sub> +  $\Psi$ <sub>JB</sub> x P<sub>D</sub>.

| Package Type    | 64-VFQFPN            |
|-----------------|----------------------|
| Body size (mm)  | 9.0 × 9.0 × 0.85 mm  |
| ePad size (mm)  | 6.00 × 6.00 mm       |
| Thermal Via     | 8 × 8 Matrix         |
| $\Psi_{JB}$     | 1.1 C/W              |
| T <sub>CB</sub> | 105°C                |
| Pn              | 2.76W <sup>[2]</sup> |

Table 32. Thermal Resistance for 64-VFQFPN Package [1]

For the variables above, the junction temperature is  $T_J = T_{CB} + Y_{JB} \times P_D = 105^{\circ}\text{C} + 1.1^{\circ}\text{C/W} \times 2.76\text{W} = 108^{\circ}\text{C}$ . Since this operating junction temperature is below the maximum operating junction temperature of 125°C, there are no long term reliability concerns. In addition, since the junction temperature at which the device was characterized using forced convection is 108.6°C, this device can function without the degradation of the specified AC or DC parameters.

<sup>1.</sup> Standard JEDEC 2S2P multilayer PCB.

<sup>2.</sup> See Table 7, test case 7.

## 6. Registers

### 6.1 Register Descriptions

This section contains a list of all addressable registers and a register description, sorted by function, followed for a detailed description of each bit field for each register. Several functional blocks with multiple instances in this device have individual registers controlling their settings, but since the registers have an identical format and bit meaning, they are described only once, but with an additional table to indicate their addresses and default values. All writable register fields will power up with default values as indicated in the factory "Default" column unless altered by values loaded from non-volatile storage during the initialization sequence.

Fixed read-only bits will have defaults as indicated in their specific register descriptions. Read-only status bits will reflect valid status of the conditions they are designed to monitor once the internal power-up reset has been released. Unused registers and bit positions are Reserved. Reserved bit fields will be unaffected by writes and are undefined on reads

**Table 33. Configuration Registers** 

| Register Address | Register Description                    |
|------------------|---|
| 0x00-0x17        | Reserved                                |
| 0x18-0x1B        | SYSREF, DCB and Phase Alignment Control |
| 0x1C             | Device ID                               |
| 0x1D-0x1F        | Reserved                                |
| 0x20             | Channel A, Output Divider               |
| 0x21             | Channel A Delay ΦCLK_A                  |
| 0x22             | Channel A PD                            |
| 0x23             | Reserved                                |
| 0x24             | Output State QCLK_A0                    |
| 0x25             | Output State QCLK_A1                    |
| 0x26             | Output State QCLK_A2                    |
| 0x27             | Reserved                                |
| 0x28             | ΦREF_A0 Delay, MUX                      |
| 0x29             | ΦREF_A1 Delay, MUX                      |
| 0x2A             | ΦREF_A2 Delay, MUX                      |
| 0x2B             | Reserved                                |
| 0x2C             | Output State QREF_A0                    |
| 0x2D             | Output State QREF_A1                    |
| 0x2E             | Output State QREF_A2                    |
| 0x2F             | Reserved                                |
| 0x30             | Channel B, Output Divider               |
| 0x31             | Channel B Delay ΦCLK_ <i>B</i>          |
| 0x32             | Channel B PD                            |
| 0x33             | Reserved                                |
| 0x34             | Output State QCLK_B0                    |
| 0x35             | Output State QCLK_B1                    |
| 0x36-0x37        | Reserved                                |
| 0x38             | ΦREF_B0 Delay, MUX                      |
| 0x39             | ΦREF_B1 Delay, MUX                      |
| 0x3A-0x3B        | Reserved                                |
| 0x3C             | Output State QREF_B0                    |

Table 33. Configuration Registers (Cont.)

| Register Description      |  |  |  |  |  |
|---------------------------|--|--|--|--|--|
| Output State QREF_B1      |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Channel C, Output Divider |  |  |  |  |  |
| Channel C Delay ΦCLK_C    |  |  |  |  |  |
| Channel C PD              |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Output State QCLK_C0      |  |  |  |  |  |
| Output State QCLK_C1      |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| ΦREF_C0 Delay, MUX        |  |  |  |  |  |
| ΦREF_C1 Delay, MUX        |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Output State QREF_C0      |  |  |  |  |  |
| Output State QREF_C1      |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Channel D, Output Divider |  |  |  |  |  |
| Channel D Delay ΦCLK_D    |  |  |  |  |  |
| Channel D PD              |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Output State QCLK_D       |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| ΦREF_D Delay, MUX         |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Output State QREF_D       |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| General Control           |  |  |  |  |  |
| Output State QCLK         |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Output State QREF         |  |  |  |  |  |
| Reserved                  |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
| Do not use                |  |  |  |  |  |
|                           |  |  |  |  |  |

## 6.2 Channel and Clock Output Registers

The content of the channel register and clock output registers set the clock divider, output style, amplitude, power down state, enable state and the clock phase delay.

Table 34. Channel and Clock Output Register Bit Field Locations

|                     | Bit Field Location |                |                |                |                      |                |                    |               |  |  |  |  |  |  |
|---------------------|--------------------|----------------|----------------|----------------|----------------------|----------------|--------------------|---------------|--|--|--|--|--|--|
| Register<br>Address | D7                 | D6             | D5             | D4             | D3                   | D2             | D1                 | D0            |  |  |  |  |  |  |
| 0x20                |                    |                |                |                |                      | N_A            | [3:0]              | •             |  |  |  |  |  |  |
| 0x30                | Reserved           | Reserved       | Reserved       | Reserved       |                      | N_B            | [3:0]              |               |  |  |  |  |  |  |
| 0x40                | Reserved           | Reserved       | Reserved       | Reserved       |                      | N_C            | [3:0]              |               |  |  |  |  |  |  |
| 0x50                |                    |                |                |                |                      | N_D            | [3:0]              |               |  |  |  |  |  |  |
| 0x21                | ΦCLK_A[7:0]        |                |                |                |                      |                |                    |               |  |  |  |  |  |  |
| 0x31                | ΦCLK_B[7:0]        |                |                |                |                      |                |                    |               |  |  |  |  |  |  |
| 0x41                |                    |                |                | ΦCLK_          | C[7:0]               |                |                    |               |  |  |  |  |  |  |
| 0x51                |                    |                |                | ΦCLK_          | D[7:0]               |                |                    |               |  |  |  |  |  |  |
| 0x22                | PD_A               |                |                |                |                      |                |                    |               |  |  |  |  |  |  |
| 0x32                | PD_B               | Decembed       | Reserved       | Reserved       | Reserved             | Reserved       | Reserved           | Reserved      |  |  |  |  |  |  |
| 0x42                | PD_C               | Reserved       | Reserved       |                |                      |                |                    | Reserved      |  |  |  |  |  |  |
| 0x52                | PD_D               |                |                |                |                      |                |                    |               |  |  |  |  |  |  |
| 0x24:<br>QCLK_A0    | PD_ <i>A0</i>      |                |                | STYLE_A0A<br>1 | A_ <i>A0A1</i> [1:0] |                | QCLKA0_A1<br>_HSTL | Reserved      |  |  |  |  |  |  |
| 0x25:<br>QCLK_A1    | PD_A1              | Reserved       | Reserved       | Reserved       | Reserved             |                | Reserved           |               |  |  |  |  |  |  |
| 0x26:<br>QCLK_A2    | PD_A2              |                |                | STYLE_A2       | A_ <i>A2</i> [1:0]   |                | QCLKA2_HS<br>TL    |               |  |  |  |  |  |  |
| 0x34:<br>QCLK_B0    | PD_ <i>B0</i>      | Reserved       | Reserved       | STYLE_B0B<br>1 | A_B0B1[1:0]          |                | QCLKB0_B1<br>_HSTL | Reserved      |  |  |  |  |  |  |
| 0x35:<br>QCLK_B1    | PD_ <i>B1</i>      | Reserved       | Reserved       | Reserved       | Reserved             |                | Reserved           | Reserved      |  |  |  |  |  |  |
| 0x44:<br>QCLK_C0    | PD_C0              | Reserved       | Reserved       | STYLE_C0       | A_C                  | <i>0</i> [1:0] | QCLK0_HST<br>L     | Reserved      |  |  |  |  |  |  |
| 0x45:<br>QCLK_C1    | PD_C1              | Neserveu       | Neserveu       | STYLE_C1       | A_ <i>C1</i> [1:0]   |                | QCLK1_HST<br>L     | iveseived     |  |  |  |  |  |  |
| 0x54: QCLK_D        | PD_ <i>D</i>       | Reserved       | Reserved       | STYLE_D        | A_ <i>D</i> [1:0]    |                | QCLKD_HS<br>TL     |               |  |  |  |  |  |  |
| 0x74                | EN_QCLK_<br>A0     | EN_QCLK_<br>A1 | EN_QCLK_<br>A2 | EN_QCLK_B<br>0 | EN_QCLK_<br>B1       | EN_QCLK_<br>C0 | EN_QCLK_<br>C1     | EN_QCLK_<br>D |  |  |  |  |  |  |

Table 35. Channel and Clock Output Register Descriptions [1]

|                |               |  | Re   | gister De  | scriptio        | on      |                        |   |  |
|----------------|---------------|--|--|--|-----------------|---------|------------------------|---|--|
| Bit Field Name | Field<br>Type | Default (Binary)   |  |  |                 |         | Descr                  | iption  |  |
| N_x[3:0]       | R/W           | N_A = 0000 (÷1)  N_B = 001[NBC_DEF] (÷4/÷3)  N_C = 001[NBC_DEF] +4/÷3  N_D = 0000 (÷1) | Output Frequency Divider N           N_x[2:0]         Frequency Divider           0000         ÷1 (Divider bypassed and powered-down)           0001         ÷2           0010         ÷3           0011         ÷4           0100         ÷6           0101         ÷8           0110         ÷12           0111         ÷16           1000         ÷24           The default value of the N_B and N_C divider is set by pin 31 (NBC_DEF)           See Table 20. |  |                 |         |                        |   |  |
| PD_x           | R/W           | 0<br>Value: Power up   | 0 = Channel<br>1 = Channel   |  |                 | /n      |                        |   |  |
|                |               |  | H  | STL_y  | PD <sub>.</sub> | _y      |                        | Powered State of QCLK_y   |  |
|                |               | 0  |  | 0  | 0               |         | 0                      | utput QCLK_y is powered up  |  |
| PD_ <i>y</i>   | R/W           | Value: Power up  |  | 0  | 1               |         | Ou                     | tput QCLK_y is powered down   |  |
|                |               |  |  | 1  | 0               |         | 0                      | output QCLK y is powered up   |  |
|                |               |  |  | 1  | 1               |         |                        |   |  |
| ΦCLK_x[7:0]    | R/W           | 0000 0000<br>Value: 0ns  | ΦCLK_x Phase ΦCLK_x[7:0] 0000 0000 0000 0001 1111 1111   |  |                 | n units | of the in              | put period: ΦCLK_x[7:0] ÷ f <sub>IN</sub> (256 steps).  |  |
| A_y[1:0]       | R/W           | 01<br>Value: 750mV   | A_A0A1 sets  | STL = 0, \$ 100Ω acr 350mV 750mV Reserved Reserved g control be the output | STYLE oss       | bine th | ne A(mplit<br>or QCLK_ | Setting for HSTL = 0, STYLE = 1 (LVPECL) Termination: $50\Omega$ to $V_T$ $A[1:0] = 00: 350mV$ $A[1:0] = 01: 750mV$ $A[1:0] = 10: 1000mV$ $A[1:0] = 11: 1000mV$ $a[1:0] = 10: 1000mV$ $A[1:0] = 11: 1000mV$ $A[1:0] = 10: 1000mV$ $A[1:0] = 11: 1000mV$ $A[1:0] = 10: 1000mV$ |  |
|                |               |  | HSTL y   | STYLE  |                 |         |                        | ut Format.  |  |
| HSTL_y         | R/W           | 0<br>Value: AC-HCSL  | 0  |  | )               | Outp    |                        | re LVDS (requires LVDS 100Ω output  |  |
|                | 1.47.44       | disabled   | Output(s) is/are LVPECL (requires LVPECL 50Ω output termination to the specified recommended termination voltage)  |  |                 |         |                        | · · ·   |  |
|                |               | 0  | 1  | (  | )               | Rese    | rved                   |   |  |
| STYLE_y        | R/W           | Value: LVDS  | 1  | ,  | 1               |         | ut(s) is/ar<br>ound)   | e AC-HCSL (requires $50\Omega$ output termination   |  |
| EN_y           | -             | 1<br>Value: enabled  | QCLK_y Out<br>0 = QCLK_y<br>1 = QCLK_y   | Output is  | disable         |         | e logic lo             | w state   |  |

<sup>1.</sup> x = A, B, C, D; y = A0, A1A2,, B0, B1, C0, C1, D.

## 6.3 QREF\_r Output State Registers

The content of the QREF\_r output registers selects the source signal of the QREF\_r outputs, set the phase delay, the style, the amplitude, the power state, the enable state and the output bias.

Table 36. QREF\_r Output State Register Bit Field Locations [1]

| Bit Field Location  |                |                |                |                |                    |                |                 |               |  |  |  |  |
|---------------------|----------------|----------------|----------------|----------------|--------------------|----------------|-----------------|---------------|--|--|--|--|
| Register<br>Address | D7             | D6             | D5             | D4             | D3                 | D3 D2 D1       |                 | D0            |  |  |  |  |
| 0x28:<br>QREF_A0    |                |                |                | MUX_A0         |                    | ΦREF_A0[2:0]   |                 |               |  |  |  |  |
| 0x29:<br>QREF_A1    | Reserved       | Reserved       | Reserved       | MUX_A1         |                    | ΦREF_A1[2:0]   |                 | Reserved      |  |  |  |  |
| 0x2A:QREF_A<br>2    |                |                |                | MUX_A2         |                    | ΦREF_A2[2:0]   |                 |               |  |  |  |  |
| 0x38:<br>QREF_B0    | Reserved       | Reserved       | Reserved       | MUX_B0         |                    | ΦREF_B0[2:0]   |                 | Reserved      |  |  |  |  |
| 0x39:<br>QREF_B1    | Reserved       | Reserved       | Reserved       | MUX_B1         |                    | ΦREF_B1[2:0]   |                 | Reserved      |  |  |  |  |
| 0x48:<br>QREF_C0    |                |                | Reserved       | MUX_C0         |                    | ΦREF_C0[2:0]   |                 | Reserved      |  |  |  |  |
| 0x49:<br>QREF_C1    | Reserved       | Reserved       | Reserved       | MUX_C1         |                    | ΦREF_C1[2:0]   |                 | Reserved      |  |  |  |  |
| 0x58: QREF_D        | Reserved       | Reserved       | Reserved       | MUX_D          | ΦREF_D[2:0]        |                |                 | Reserved      |  |  |  |  |
| 0x2C:<br>QREF_A0    | PD_ <i>A0</i>  |                | BIAS_A0        | STYLE_A0       | A_ <i>A</i> (      | 0[1:0]         | QREFA0_HS<br>TL |               |  |  |  |  |
| 0x2D:<br>QREF_A1    | PD_A1          | Reserved       | BIAS_A1        | STYLE_A1       | A_ <i>A</i>        | <i>1</i> [1:0] | QREFA1_HS<br>TL | Reserved      |  |  |  |  |
| 0x2E:<br>QREF_A2    | PD_A2          |                | BIAS_A2        | STYLE_A2       | A_ <i>A</i> :      | 2[1:0}         | QREFA2_HS<br>TL |               |  |  |  |  |
| 0x3C:<br>QREF_B0    | PD_ <i>B0</i>  | Reserved       | BIAS_B0        | STYLE_B0       | A_ <i>B</i> (      | 0[1:0]         | QREFB0_HS<br>TL | Reserved      |  |  |  |  |
| 0x3D:<br>QREF_B1    | PD_ <i>B1</i>  | rteserveu      | BIAS_B1        | STYLE_B1       | A_ <i>B</i>        | <i>1</i> [1:0] | QREFB1_HS<br>TL | reserved      |  |  |  |  |
| 0x4C:<br>QREF_C0    | PD_C0          | Reserved       | BIAS_C0        | STYLE_C0       | A_ <i>C0</i> [1:0] |                | QREFC0_H<br>STL | Reserved      |  |  |  |  |
| 0x4D:<br>QREF_C1    | PD_C1          | i keserved     | BIAS_C1        | STYLE_C1       | A_C1[1:0]          |                | QREFC1_H<br>STL | ivezei ved    |  |  |  |  |
| 0x5C: QREF_D        | PD_ <i>D</i>   | Reserved       | BIAS_D         | STYLE_D        | A_ <i>D</i> [1:0]  |                | QREFD_HS<br>TL  | Reserved      |  |  |  |  |
| 0x76                | EN_QREF_<br>A0 | EN_QREF_<br>A1 | EN_QREF_<br>A2 | EN_QREF_B<br>0 | EN_QREF_<br>B1     | EN_QREF_<br>C0 | EN_QREF_<br>C1  | EN_QREF_<br>D |  |  |  |  |

<sup>1.</sup> r = A0, A1A2,, B0, B1, C0, C1, D.

Table 37. QREF\_r Output State Register Descriptions [1]

|                      |               |                                | F  | Register Descrip  | otion  | _   |  |  |  |  |
|----------------------|---------------|--------------------------------|--|---|--|---|--|--|--|--|
| Bit Field<br>Name    | Field<br>Type | Default (Binary)               | Description  |   |  |   |  |  |  |  |
| MUX_r                | R/W           | 1<br>Value: QREF_r =<br>SYSREF | 0 = QREF_r output signal source is the channel's clock signal<br>1 = QREF_r output signal source is the centrally generated SYSREF signal  |   |  |   |  |  |  |  |
|                      |               |                                | QREF_r delay   | SYSREF Phase Delay: $ QREF\_r \text{ delay} = \Phi REF\_r[2:0] \cdot T_{DCB}. $ Delay values for $f_{DCO} = 983.04 \text{MHz}$ . Delay values are a function of $T_{DCB}$ . |  |   |  |  |  |  |
|                      |               |                                | ΦDEE 43:01   | QREF_r delay  | in ps for a DLC[1  | :0] setting of:   |  |  |  |  |
|                      | 000           | ΦREF_r[2:0]                    | 00   | 01  | 10   | 11  |  |  |  |  |
| ΦREF_ <i>r</i> [2:0] | R/W           | Value: 0ps                     | 000  | 0   | 0  | 0   | 0  |  |  |  |
|                      |               |                                | 001  | 131   | 262  | 393   | 524  |  |  |  |
|                      |               |                                | 010  | 262   | 524  | 786   | 1048   |  |  |  |
|                      |               |                                |  |   |  |   |  |  |  |  |
|                      |               |                                | 111  | 917   | 1834   | 2751  | 3668   |  |  |  |
|                      |               |                                | LVPECL mode.  0 = Normal ope   | F_r output LVDS  eration  |  |   | ole to QREF_r outputs set to                             |  |  |  |
|                      |               |                                | BIAS_TYPE  | BIAS r  | QREF <i>r</i> output operation if set to LVDS.   |   |  |  |  |  |
| DIA C =              | DAM           |                                | 0  | 0   | QREF_r outputs are initially logic low (QREF_r = L, nQREF_r = H) and will start switching on the first rising edge of the REF input. Use in DC-coupled applications. |   |  |  |  |  |
| BIAS_r               | R/W           | 0                              | 0  | 1   | Disabled with static low/high levels. During a SYSREF event, the output remains at static low levels (QREF_r = L, nQREF_r = H).                                      |   |  |  |  |  |
|                      |               |                                | 1 [2]  | 0   | LVDS crosspoin   | Both QREF_r and nQREF_r outputs are initially set to the LVDS crosspoint level (VOS) and will start switching on the first rising edge of the REF input. Use in AC-coupled applications |  |  |  |  |
|                      |               |                                | 1 <sup>[2]</sup>   | 1   |  |   | S crosspoint voltage. During ains at the LVDS crosspoint |  |  |  |
|                      |               |                                | QREF_r Outpu   | t Amplitude   | •  |   |  |  |  |  |
|                      |               | 01                             | Setting for STY<br>Termination: 10   | 'LE = 0 (LVDS)<br>00Ω across  |  | Setting for STYLE = 1 (LVPECL) Termination: $50\Omega$ to V <sub>T</sub>  |  |  |  |  |
| A_ <i>r</i> [1:0]    | R/W           | Value: 750mV                   | A[1:0] = 00: 35<br>A[1:0] = 01: 75<br>A[1:0] = 10: Re<br>A[1:0] = 11: Re   | 0mV<br>served   |  | A[1:0] = 00: 350r<br>A[1:0] = 01: 750r<br>A[1:0] = 10: 1000<br>A[1:0] = 11: 1000  | mV<br>DmV  |  |  |  |
| PD_r                 | R/W           | 0<br>Value:<br>Powered up      | QREF_r Output 0 = Output is pour 1 = Output is pour | owered up   | TYLE, EN and Af  | 1:0] settings have  | no effect  |  |  |  |
|                      |               |                                | HSTL_r   | STYLE_r   | QREF_x Outpu   |   |  |  |  |  |
| HCT! "               | D/4/          | 0                              | 0  | 0   |  |   | 00Ω output termination)                                  |  |  |  |
| HSTL_r               | R/W           | Value: AC-HCSL<br>disabled     | 0  | 1   | Output is LVPE   | ` '   | ECL 50Ω output termination                               |  |  |  |

Table 37. QREF\_r Output State Register Descriptions [1] (Cont.)

|                   | Register Description |                      |  |               |  |  |  |  |  |  |  |  |
|-------------------|----------------------|----------------------|--|---------------|--|--|--|--|--|--|--|--|
| Bit Field<br>Name | Field<br>Type        | Default (Binary)     | Description  |               |  |  |  |  |  |  |  |  |
|                   |                      | 0                    | 1  | 0             | Reserved   |  |  |  |  |  |  |  |
| STYLE_r           | R/W                  | Value: LVDS          | 1  | 1             | Output is AC-HCSL (requires $50\Omega$ output termination to ground) |  |  |  |  |  |  |  |
| EN_r              | R/W                  | 0<br>Value: Disabled | QREF_r Outpu<br>0 = Output is di<br>1 = Output is er | sabled at the | logic low state  |  |  |  |  |  |  |  |

<sup>1.</sup> r = A0, A1, A2, B0, B1, C0, C1, D. x = A, B, C, D.

## 6.4 SYSREF, DCB, and Phase Alignment Control Registers

Table 38. SYSREF, DCB and Phase Alignment Control Register Bit Field Locations

|                     | Bit Field Location |            |          |          |          |          |          |          |  |  |  |  |  |  |
|---------------------|--------------------|------------|----------|----------|----------|----------|----------|----------|--|--|--|--|--|--|
| Register<br>Address | D7                 | D6         | D5       | D4       | D3       | D2       | D1       | D0       |  |  |  |  |  |  |
| 0x18                | PD_S               | Reserved   | Reserved | Reserved | Reserved | Reserved | Reserved | Reserved |  |  |  |  |  |  |
| 0x19                | BIAS_TYPE          | DLC        | [1:0]    | Reserved | Reserved | Reserved | Reserved | M_DCB[8] |  |  |  |  |  |  |
| 0x1A                |                    | M_DCB[7:0] |          |          |          |          |          |          |  |  |  |  |  |  |
| 0x1B                | N_ALIGN            | P_DCB[6:0] |          |          |          |          |          |          |  |  |  |  |  |  |

Table 39. SYSREF, DCB, and Phase Alignment Control Register Descriptions

|                   |                 |                           |                  | Register Des   | scription  |  |   |   |  |  |
|-------------------|-----------------|---------------------------|------------------|--|--|--|---|---|--|--|
| Bit Field<br>Name | Field<br>Type   | Default<br>(Binary)       | Description      |  |  |  |   |   |  |  |
| PD_S              | R/W             | 0<br>Value:<br>Powered up | 0 = SYSREF fu    | SYSREF Global Power-down:<br>0 = SYSREF functional blocks are powered up<br>1 = SYSREF functional blocks are powered down                              |  |  |   |   |  |  |
|                   |                 |                           | Global to all QF | YSREF Output Voltage Bias:  lobal to all QREF_r outputs bit to control the LVDS output operation. Not applicable to QREF_r  utputs set to LVPECL mode. |  |  |   |   |  |  |
|                   |                 |                           | BIAS_TYPE        | BIAS_r   | QREF_r output operation if set to LVDS.  |  |   |   |  |  |
|                   |                 |                           |                  |  |  |  | 0 | 0 | QREF_r outputs are initially logic low (QREF_r = L, nQREF_r = H) and will start switching on the first rising edge of the REF input. Use in DC-coupled applications. |  |
| BIAS_TYPE         | BIAS_TYPE R/W 0 |                           |                  | 1  | Disabled with static low/high levels. During a SYSREF event, the output remains at static low levels (QREF_r = L, nQREF_r = H).  |  |   |   |  |  |
|                   |                 |                           | 1 [1]            | 0  | Both QREF_r and nQREF_r outputs are initially set to the LVDS crosspoint level (VOS) and will start switching on the first rising edge of the REF input. Use in AC-coupled applications. |  |   |   |  |  |
|                   |                 |                           | 1 [1]            | 1  | Output is statically set to the LVDS crosspoint voltage. During a SYSREF event, the output remains at the LVDS crosspoint level (VOS).   |  |   |   |  |  |

<sup>2.</sup> For AC coupling applications (BIAS\_TYPE = 1) after setting BIAS\_TYPE to 1, set the PD\_S bit to 1 and then set it to 0; this will set QREF\_r and nQREF\_r to the LVDS crosspoint level (VOS). If SYSREF generation is started and halted, then repeat the process of setting the PD\_S bit to 1 and then setting it to 0; this will set QREF\_r and nQREF\_r to the LVDS crosspoint level (VOS).

Table 39. SYSREF, DCB, and Phase Alignment Control Register Descriptions (Cont.)

|                   | Register Description |                          |                                   |   |  |  |  |  |  |
|-------------------|----------------------|--------------------------|-----------------------------------|---|--|--|--|--|--|
| Bit Field<br>Name | Field<br>Type        | Default<br>(Binary)      | Description                       |   |  |  |  |  |  |
|                   |                      |                          | Delay Unit Mul<br>Effective delay | tiplier: unit for the SYSREF outputs is (1 + DLC[1:0]) ÷ (8 · f <sub>DCO</sub> ).   |  |  |  |  |  |
|                   |                      |                          | DLC[1:0]                          | Effective SYSREF Delay Unit for f <sub>DCO</sub> = 983.04MHz  |  |  |  |  |  |
| DLC[1:0]          | R/W                  | 00<br>Value: 131ps       | 00                                | 131ps   |  |  |  |  |  |
|                   |                      | value. 13 1ps            | 01                                | 262ps   |  |  |  |  |  |
|                   |                      |                          | 10                                | 393ps   |  |  |  |  |  |
|                   |                      |                          | 11                                | 524ps   |  |  |  |  |  |
| M_DCB[8:0]        | R/W                  | 0 0001 0000<br>Value: 16 |                                   | on Block (DCB) DCO feedback divider. Set in conjunction with f <sub>IN</sub> and P_DCB to of frequency of 983.04±20MHz: f <sub>DCO</sub> = f <sub>IN</sub> ÷ P <sub>DCB</sub> · M <sub>DCB</sub> .  |  |  |  |  |  |
| N_ALIGN           | R/W                  | 0<br>Value: ÷24          | phase alignme                     | der dividing the input clock signal ( $f_{IN}$ ) to an internal reference for the multi-device nt engine. Use ÷48 if any of the output clock divider is $N_x = \div 16$ . The divider setting on the maximum frequency $f_{REF}$ during multi-device phase alignment (see $f_{REF}$ in AC table). |  |  |  |  |  |
| P_DCB[6:0]        | R/W                  | 000 1000<br>Value: 8     |                                   | on Block (DCB) DCO input divider. Set in conjunction with $f_{IN}$ and M_DCB to achieve $y$ of 983.04±20MHz: $f_{DCO} = f_{IN} \div P_{DCB} \cdot M_{DCB}$ . DCO phase detector frequency eed 200MHz.   |  |  |  |  |  |

<sup>1.</sup> For AC coupling applications (BIAS\_TYPE = 1) after setting BIAS\_TYPE to 1, set the PD\_S bit to 1 and then set it to 0; this will set QREF\_r and nQREF\_r to the LVDS crosspoint level (VOS). If SYSREF generation is started and halted, then repeat the process of setting the PD\_S bit to 1 and then setting it to 0; this will set QREF\_r and nQREF\_r to the LVDS crosspoint level (VOS).

## 6.5 General Control Registers

Table 40. General Control Register Bit Field Locations

|                     | Bit Field Location |                |                  |                    |          |          |          |          |  |  |  |  |  |  |
|---------------------|--------------------|----------------|------------------|--------------------|----------|----------|----------|----------|--|--|--|--|--|--|
| Register<br>Address | D7                 | D6             | D5               | D4                 | D3       | D2       | D1       | D0       |  |  |  |  |  |  |
| 0x1C                | Reserved           | Reserved       | Reserved         | DEV_ID_RC<br>18016 | Reserved | Reserved | Reserved | Reserved |  |  |  |  |  |  |
| 0x6C                | Reserved           | DAC_CODE[14:8] |                  |                    |          |          |          |          |  |  |  |  |  |  |
| 0x6D                |                    |                |                  | DAC_COI            | DE[7:0]  |          |          |          |  |  |  |  |  |  |
| 0x6E                | Reserved           | Reserved       | st_any_ALIG<br>N | Reserved           | Reserved | Reserved | ST_READY | Reserved |  |  |  |  |  |  |
| 0x6F                | Reserved           | Reserved       |                  |                    | PBIAS    | [5:0]    | •        |          |  |  |  |  |  |  |
| 0x70                | INIT_CLK           | Reserved       | Reserved         | Reserved           | Reserved | Reserved | Reserved | Reserved |  |  |  |  |  |  |
| 0x71                | DCB_CAL            | Reserved       | Reserved         | Reserved           | Reserved | Reserved | Reserved | Reserved |  |  |  |  |  |  |
| 0x72                | PB_CAL             | Reserved       | Reserved         | Reserved           | Reserved | Reserved | Reserved | Reserved |  |  |  |  |  |  |
| 0x73                | MD_ALIGN_Φ         | Reserved       | Reserved         | Reserved           | Reserved | Reserved | Reserved | CPOL     |  |  |  |  |  |  |

**Table 41. General Control Register Descriptions** 

| Register Description  |            |                     |   |
|-----------------------|------------|---------------------|---|
| Bit Field Name        | Field Type | Default<br>(Binary) | Description   |
| DEV_ID_RC18016<br>[4] | R only     | 1                   | 0 = Reserved<br>1 = RC18016   |
| DAC_CODE[14:0]        | R only     | Х                   | DAC_CODE is the result of the internal DCB calibration routine. Trigger calibration by setting the DCB_CAL bit. |

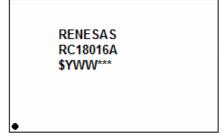
Table 41. General Control Register Descriptions (Cont.)

| Register Description |                      |                     |   |
|----------------------|----------------------|---------------------|---|
| Bit Field Name       | Field Type           | Default<br>(Binary) | Description   |
| st_any_ALIGN         | R only               | х                   | Multi-buffer phase alignment status.  0 = Alignment complete  1 = Awaiting a rising edge on REF, or alignment is in progress  |
| ST_READY             | R only               | х                   | Internal startup routine completion status. The device is ready for operation when this bit is set to 1.  0 = Incomplete 1 = Completed and device is ready for operation.   |
| PBIAS[5:0]           | R only               | Х                   | BIAS level.   |
| INIT_CLK             | W only<br>Auto-Clear | х                   | Clock divider and phase clock phase delay initialization. Set INIT_CLK = 1 to initialize $N_x$ divider and $\Phi$ CLK_x clock phase delay functions. Required as part of the startup procedure and after each change of a clock divider or clock phase delay value.   |
| PB_CAL               | W only<br>Auto-Clear | х                   | Precision Bias Calibration: Set PB_CAL to 1 starts the auto-calibration of an internal precision bias current source. The bias current is used as reference for outputs configured as LVDS. This bit will auto-clear after the calibration completed. Required to set as part of the startup procedure.     |
| DCB_CAL              | W only<br>Auto-Clear | х                   | DCB Calibration: Setting this bit to 1 will begin the auto-calibration of the DCB. The DCB provides a reference for the SYSREF delay circuits. This bit will auto-clear. This bit should be set as part of the startup procedure. The result of the calibration routine is stored in the DAC_CODE register. |
| CPOL                 | R/W                  | 0                   | SPI Read Operation SCLK Polarity:  0 = Data bits on MISO are output at the falling edge of SCLK edge.  1 = Data bits on MISO are output at the rising edge of SCLK edge.  |
| MD_ALIGN_Φ           | R/W<br>Auto-clear    | 0                   | Multi-Buffer Phase Alignment Start Writing 1 to this bit will start the multi-buffer phase alignment process and cause the st_any_ALIGN bit to be set to 1. This bit will auto-clear.   |

## 7. Package Outline Drawings

The package outline drawings are located at the end of this document and are accessible from the Renesas website. The package information is the most current data available and is subject to change without revision of this document.

## 8. Marking Diagram



- Line 1 indicates the manufacturer.
- Line 2 indicates the part number.
- Line 3 indicates the following:
  - "Y" is the last digit of the year; "WW" is the work week number when the part was assembled.
  - "\$" denotes the mark code.
  - "\*\*\*" denotes the last three characters of the assembly lot number.

# 9. Ordering Information

| Part Number     | Package Description     | Carrier Type                                     | Temperature Range |
|-----------------|-------------------------|--|-------------------|
| RC18016AGN1#BB0 | 9.0 × 9.0 mm, 64-VFQFPN | Tray   |                   |
| RC18016AGN1#HB0 |                         | Tape and Reel, Pin 1 Orientation:<br>EIA-481-C   | -40 to +105°C     |
| RC18016AGNC#KB0 |                         | Tape and Reel, Pin 1 Orientation:<br>EIA-481-D/E |                   |

Table 42. Pin 1 Orientation in Tape and Reel Packaging

| Part Number Suffix | Pin 1 Orientation        | Illustration  |
|--------------------|--------------------------|---|
| НВ0                | Quadrant 1 (EIA-481-C)   | CARRIER TAPE TOPSIDE (Round Sprocket Holes)  USER DIRECTION OF FEED |
| KB0                | Quadrant 2 (EIA-481-D/E) | CARRIER TAPE TOPSIDE (Round Sprocket Holes)  USER DIRECTION OF FEED |

# 10. Glossary

| Abbreviation      | Description   |  |
|-------------------|---|--|
| Index x           | Denominates a channel, channel frequency divider and the associated configuration bits. Range: A, B, C, D.  |  |
| Index y           | Denominates a QCLK output and associated configuration bits. Range: A0, A1, A2, B0, B1, C0, C1, D.  |  |
| Index r           | Denominates a QREF output and associated configuration bits. Range: A0, A1, A2, B0, B1, C0, C1, D.  |  |
| V <sub>DD_V</sub> | Denominates voltage supply pins. Range: V <sub>DD_QCLKA</sub> , V <sub>DD_QREFA01</sub> , V <sub>DD_QREFA2</sub> , V <sub>DD_QCLKB</sub> , V <sub>DD_QREFB</sub> , V <sub>DD_QCLKD</sub> , V <sub>DD_QREFD</sub> , V <sub>DD_QCLK</sub> , V <sub>DD_QREF</sub> , V <sub>DD_QREF</sub> , V <sub>DD_QCLK</sub> , V <sub>DD</sub> |  |
| []                | Index brackets describe a group associated with a logical function or a bank of outputs.  |  |
| {}                | List of discrete values.  |  |

# 11. Revision History

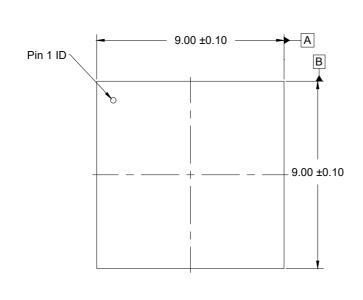
| Revision | Date         | Description   |
|----------|--------------|---|
| 1.01     | Oct 11, 2024 | <ul> <li>Updated item 3 in Device Startup, Reset, and Synchronization.</li> <li>Changed EN_REF_D to EN_QREF_D for register 0x76 in Table 36.</li> <li>Added st_any_ALIGN to Table 40 and Table 41.</li> <li>Updated the description of MD_ALIGN_Φ in Table 41.</li> </ul> |
| 1.00     | Jul 19, 2024 | Initial release.  |

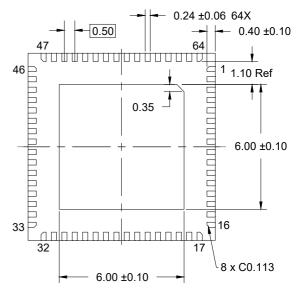




Package Code: NLG64P5 64-VFQFPN 9.0 x 9.0 x 0.9 mm Body, 0.50mm Pitch

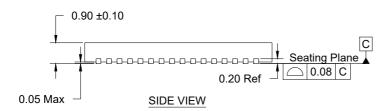
PSC-4147-05, Revision: 06, Date Created: Aug 07, 2023

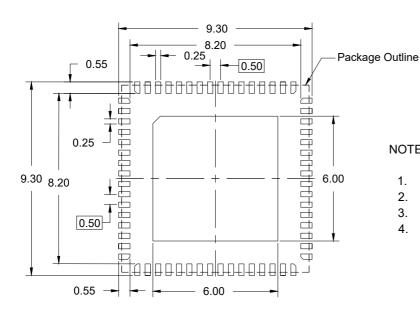




#### TOP VIEW

### **BOTTOM VIEW**





#### NOTES:

- JEDEC compatible. 1.
- All dimensions are in mm and angles are in degrees.
- Use ±0.05 mm for the non-toleranced dimensions.
- Numbers in ( ) are for references only.

RECOMMENDED LAND PATTERN (PCB Top View, NSMD Design)

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